

RC2121xA

This document describes programming information for the RC2121xA. Detailed register definitions can be located by following the links in the document.

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1. Overview

The [Programming Description](#) section provides a high-level overview of registers that system software will typically interact with during system operation.

The [Registers](#) section provides detailed descriptions of all user-accessible registers in the device. These registers are loaded from OTP at boot time. OTP images are created using the Renesas [RICBox](#) software.

Note: For device information and electrical characteristics, see the [RC2121xA Datasheet](#).

2. Programming Description

2.1 Paging

The RC2121xA can be configured by OTP for 16 bits or 8 bits of internal I2C addressing. Internally registers are addressed by 16 bits. If 16 bit I2C addresses are used then paging is not used.

If the RC2121xA is configured for 8 bits of I2C addressing then paging must be used as described:

- Address 0xFC is the 32 bit page register, and is accessible independent of page register setting.
 - 0xFC – Write to 0x0.
 - 0xFD – Write page offset, this becomes the upper 8 bits of the internal address.
 - 0xFE – Write to 0x0.
 - 0xFF – Write to 0x0.

2.2 Scratch

S/W may make use of a dedicated scratch pad register.

- SCRATCH0: may be used as scratch pad.

2.3 Output Enables

Output Enables may be configured via OTP configuration to be under S/W register control, or pin control. The following describes the S/W register control. S/W register control takes precedence over pin control.

- Writing OUT_CTRL.out_dis to a “1” will always disable a particular output.
- Writing OUT_CTRL.out_dis to a “0” will enable a particular output if:
 - There is no OE pin associated with the output based on OTP configuration.
 - Or the OE pin is enabling the output.

2.4 GPIO Pins

The GPIO pins may be configured via OTP to have special functions, i.e. OE, or may be general purpose R/W bits. The following describes the S/W register control and status:

- GPO_CTRL: Will determine the output value, when configured as general purpose output.
- GPIO_STS.gpio_sts: Displays the current logic level of the pins.
- STARTUP_STS: Displays the logic level of the pins latched at power on.

2.5 GPI Pins

Note that GPI pins are only available in variants that use a single crystal.

The GPI pins may be configured via OTP to have special functions, i.e. OE, or may be general purpose RO bits. The following describes the S/W register status:

- GPIO_STS.gpi_sts: Displays the current logic level of the pins.

2.6 Event handling

Device Events are captured in the DEVICE_EVENT register. These events indicate that a monitor has detected an issue with the operation of the device. These bits are all RW1C, H/W sets the bit on the event, and S/W can clear individual bits by writing a 0x1 to the desired bit. Some of the events may persist, and H/W will immediately set the associated RW1C bit again. Events may be mapped to an interrupt see [Interrupts](#) or a fault see [Faults](#).

2.7 Interrupts

Events that are configured to an interrupt are programmed via the INT_EN register. When the corresponding bit is set in the DEVICE_EVENT register, and the event is enabled in the INT_EN register (and the device_int_en bit is set) then the INT GPIO pin is asserted, if the INT pin has been configured.

The interrupt handler should read the DEVICE_EVENT and INT_EN register to see what events have occurred and which are mapped to interrupts.

It is also possible to use polling for interrupt status via DEVICE_STS.device_int_sts, rather than the GPIO INT pin.

- DEVICE_EVENT: RW1C status bits for all events.
- INT_EN: RW control bits to select which events cause interrupts via GPIO pin.
- DEVICE_STS.device_int_sts: RO bit for interrupt status.

Once the interrupt source has been determined the associated interrupt should be cleared to prevent further interrupts from the same source. The process for this depends on the particular interrupt, as described in the following sections.

Table 1. DEVICE_EVENT Interrupt Type Mapping

bit	field	type
0	apl_lol	once
1	los0_evt	persistent
2	los1_evt	persistent
3	xtal_ppm_warn	persistent
4	xtal_ppm_err	persistent
5	xtal0_st_er	persistent
6	xtal1_st_er	persistent
18:7	freq[11:0]_evt	output
19	i2c_crc_err	once
20	dig_bist_fail	once
21	ana_bist_fail	once
22	csr_sig_fail	once
23	csr_sig_reload	once
24	xtal_switch	once
25	dual_xtal_fail	once

Table 1. DEVICE_EVENT Interrupt Type Mapping (Cont.)

bit	field	type
26	otp_crc_err	once
27	otp_load_fail	once

2.7.1 Persistent Type

Persistent type interrupts generally will continue to set the RW1C bit in the DEVICE_EVENT register, and thus clearing the interrupt RW1C bit is generally not effective. These interrupts should be cleared via INT_EN. When the interrupt is disabled it will not longer contribute to INT pin assertion. The RW1C bit in the DEVICE_EVENT register will continue operate.

2.7.2 Once Type

Once type interrupts generally will set the RW1C bit in the DEVICE_EVENT register once, and thus clearing the interrupt RW1C bit is generally effective. These interrupts should be cleared via RW1C bit in the DEVICE_EVENT register. When the interrupt RW1C is cleared it will no longer contribute to INT pin assertion.

2.7.3 Output type

These types refer to interrupts related to the output monitor. The interrupt handler should process these interrupts as follows:

- Write OUT_CTRL.out_dis with 1 to disable affected output, Note that H/W will automatically disable the output. Disabling the output via this register is required to keep it disabled while the interrupt is cleared.
- Write FREQ_CLOCK_SEL.freq_out_sel/freq_outb_sel to 0.
- write DEVICE_EVENT with 1 to clear RW1C bit.

When the interrupt RW1C is cleared it will no longer contribute to INT pin assertion.

2.8 Faults

Events that are configured to an fault are programed via the FAULT_EN register. When the corresponding bit is set in the DEVICE_EVENT register, and the event is enabled in the FAULT_EN register (and the device_fault_en bit is set) then the FAULT GPIO pin is asserted.

When a fault occurs the device goes to the safe state as described in the RC2121xA data sheet.

2.9 Direct Fault Insertion

To aid S/W development a direct fault insertion mechanism is available. The EVENT_GEN register contains bits that when written to a 0x1 trigger the corresponding bit in the DEVICE_EVENT register. This does not affect the operation of the RC2121xA, outputs, etc. continue to operate normally.

- EVENT_GEN: RW control bits to generate events.

2.10 Other Status Registers

The following registers contain status information that may be of interest to system S/W.

- DEVICE_STS.xtal_sel_sts: which crystal is currently used to lock the APLL.
- LOSMON_STS: status information on crystals.
- PPM_MON_STS: current ppm difference between the two crystals.

2.11 Fault Insertion

Fault insertion may also be performed by writing specific registers that cause an output or other circuit to fail. This will mimic the actual event, and outputs will be affected. This is provided to aid S/W development to various fault scenarios in RC2121xA. The registers that are used for fault insertion require that the lock bit be disabled. The lock bit prevents configurations registers, that should not be modified during normal operation, from being modified. The following assumes that the various monitors have been configured and enabled as part of the OTP image.

- REG_LOCK: clear register lock to perform fault insertion.
 - Register locking not implemented for TV, this step can be skipped.
- To set DEVICE_EVENT.apll_lol: read modify write APLL_FB_DIV_INT, by adding 2.
- To set DEVICE_EVENT.los0_evt: write LOSMON_CNFG_0.los_thresh to 0x1.
- To set DEVICE_EVENT.los1_evt: write LOSMON_CNFG_1.los_thresh to 0x1.
- To set DEVICE_EVENT.xtal_ppm_warn write PPM_CNFG.ppm_warn_thresh to 0x1.
- To set DEVICE_EVENT.xtal_ppm_err write PPM_CNFG.ppm_err_thresh to 0x1.
- To set DEVICE_EVENT.xtal0_st_err write ANA_CLK_EN.en_xtal0_hdiv_dig to 0x0.
- To set DEVICE_EVENT.xtal1_st_err write ANA_CLK_EN.en_xtal1_hdiv_dig to 0x0.
- To set DEVICE_EVENT.freq[11:0]_evt write FREQMON_THRESH_[11:0].freq_max_thresh 0x1.
 - Output must be enabled first.
 - Must be configured via OTP to have monitor active.
- To set DEVICE_EVENT.i2c_crc_err create I2C access with incorrect CRC.
- To set DEVICE_EVENT.dig_bist_fail write EVENT_GEN.dig_bist_fail_gen.
- To set DEVICE_EVENT.ana_bist_fail write EVENT_GEN.ana_bist_fail_gen.
- To set DEVICE_EVENT.csr_sig_fail: modify CSR_SIG.csr_sig_exp. Only works in device is configured to not reload registers on error.
- To set DEVICE_EVENT.csr_sig_reload: modify CSR_SIG.csr_sig_exp. Only works in device is configured to reload registers on error.
- To set DEVICE_EVENT.xtal_switch write LOSMON_CNFG_0.los_thresh to 0x1
- To set DEVICE_EVENT.dual_xtal_fail write LOSMON_CNFG_0.los_thresh to 0x1 and write LOSMON_CNFG_1.los_thresh to 0x1.
- To set DEVICE_EVENT.otp_crc_err write EVENT_GEN.otp_crc_err_gen.
- To set DEVICE_EVENT.otp_load_fail write EVENT_GEN.otp_load_fail_gen.

After a fault has been inserted a power on reset should be issued to return the device to normal operation.

3. Registers

Table 2. Registers

Module Base Address (Hex)	Name	Module Description	Link
0x0	GLOBAL	Global control and status registers	GLOBAL
0x40	SSI	I2C registers	SSI
0x48	XO[0]	XO control registers	XO
0x4C	XO[1]	Same as XO[0]	XO
0x50	SYSDIV	System clock registers	SYSDIV
0x58	XTALMON	Crystal monitoring registers	XTALMON
0x60	LOSMON[0]	LOS monitor registers	LOSMON
0x64	LOSMON[1]	Same as LOSMON[0]	LOSMON
0x70	FREQMON[0]	Bank output frequency monitor registers	FREQMON
0x78	FREQMON[1]	Same as FREQMON[0]	FREQMON
0x80	FREQMON[2]	Same as FREQMON[0]	FREQMON
0x88	FREQMON[3]	Same as FREQMON[0]	FREQMON
0x90	FREQMON[4]	Same as FREQMON[0]	FREQMON
0x98	FREQMON[5]	Same as FREQMON[0]	FREQMON
0xA0	FREQMON[6]	Same as FREQMON[0]	FREQMON
0xB0	APLL	APLL control registers	APLL
0xF0	SSC[0]	Spread spectrum registers	SSC
0xF4	SSC[1]	Same as SSC[0]	SSC
0x100	IOD[0]	Integer Output Divider registers	IOD
0x108	IOD[1]	Same as IOD[0]	IOD
0x110	HPFOD[0]	High Performance Fractional Output Divider registers	HPFOD
0x120	HPFOD[1]	Same as HPFOD[0]	HPFOD
0x130	HPFOD[2]	Same as HPFOD[0]	HPFOD
0x140	DCD[0]	DCD control registers for HPFOD's	DCD
0x150	DCD[1]	Same as DCD[0]	DCD
0x160	DCD[2]	Same as DCD[0]	DCD
0x170	LPFOD[0]	Limited Performance Fractional Output Divider Registers	LPFOD
0x180	LPFOD[1]	Same as LPFOD[0]	LPFOD
0x190	OUT[0]	Output control registers	OUT
0x194	OUT[1]	Same as OUT[0]	OUT
0x198	OUT[2]	Same as OUT[0]	OUT
0x19C	OUT[3]	Same as OUT[0]	OUT
0x1A0	OUT[4]	Same as OUT[0]	OUT
0x1A4	OUT[5]	Same as OUT[0]	OUT
0x1A8	OUT[6]	Same as OUT[0]	OUT

Table 2. Registers

Module Base Address (Hex)	Name	Module Description	Link
0x1AC	OUT[7]	Same as OUT[0]	OUT
0x1B0	OUT[8]	Same as OUT[0]	OUT
0x1B4	OUT[9]	Same as OUT[0]	OUT
0x1B8	OUT[10]	Same as OUT[0]	OUT
0x1BC	OUT[11]	Same as OUT[0]	OUT
0x1C0	BANK[0]	Output bank control registers	BANK
0x1C4	BANK[1]	Same as BANK[0]	BANK
0x1C8	BANK[2]	Same as BANK[0]	BANK
0x1CC	BANK[3]	Same as BANK[0]	BANK
0x1D0	BANK[4]	Same as BANK[0]	BANK
0x1D4	BANK[5]	Same as BANK[0]	BANK
0x1D8	BANK[6]	Same as BANK[0]	BANK
0x1F0	GPI[0]	GPI control registers,	GPI
0x1F4	GPI[1]	Same as GPI[0]	GPI
0x200	GPIO[0]	GPIO control registers	GPIO
0x204	GPIO[1]	Same as GPIO[0]	GPIO
0x208	GPIO[2]	Same as GPIO[0]	GPIO
0x20C	GPIO[3]	Same as GPIO[0]	GPIO
0x210	GPIO[4]	Same as GPIO[0]	GPIO
0x214	GPIO[5]	Same as GPIO[0]	GPIO
0x218	GPIO[6]	Same as GPIO[0]	GPIO
0x220	INT	Interrupt and fault registers	INT
0x280	STATUS	Status registers	STATUS
0x2C0	DCD_STATUS[0]	DCD Status registers	DCD_STATUS
0x2C8	DCD_STATUS[1]	Same as DCD_STATUS[0]	DCD_STATUS
0x2D0	DCD_STATUS[2]	Same as DCD_STATUS[0]	DCD_STATUS
0x2E0	CTRL	Control registers	CTRL

3.1 GLOBAL

Global control and status registers.

Table 3. GLOBAL Register Index

Offset (Hex)	Register Module Base Address: 0x0	
	Register Name	Register Description
0x0	VENDOR_ID	Vendor ID and Device ID Type
0x2	DEVICE_ID	Device ID
0x4	DEVICE_REV	Font ID, Analog Revision, and Digital Revision
0x6	DEVICE_PGM	Device Dash Code

Table 3. GLOBAL Register Index

Offset (Hex)	Register Module Base Address: 0x0	
	Register Name	Register Description
0x8	DEVICE_CNFG	Device Configuration Settings
0xC	CNFG_LOCK	OTP Lock Control
0x14	SW_RESET	Software Reset Bits
0x1C	FREQ_WINDOW_CNFG	Frequency Monitor Window Configuration
0x20	FREQ_CLOCK_SEL	Output Frequency Monitor Control
0x24	MISC_CNFG	Configuration Settings
0x2C	DIG_POST_CNFG	Digital POST Disable Controls
0x30	ANA_POST_CNFG	Analog POST Disable Controls
0x34	POST_FREQMON_CNFG	POST Output Frequency Monitor Configuration
0x38	POST_APLL_FB_DIV_LOL	POST APLL LOL Feedback Divider Integer Setting
0x3C	POST_PPM_CNFG	POST Crystal PPM Monitor Configuration
0x3E	POST_LOS_THRESH	POST LDO Bias Fault Detection Settings

3.1.1 VENDOR_ID

Vendor ID and Device ID Type.

VENDOR_ID Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:12	dev_id_type	RO	0x1	Device ID Block Type. A value of 0x1 indicates that this register is followed by a 16-bit Device ID register and an 16-bit Device Revision register, and a 16-bit Device Programming register.
11	reserved	RO	0x0	Reserved
10:0	vendor_id	RO	0x33	Vendor ID. IDT JEDEC ID.

3.1.2 DEVICE_ID

Device ID.

DEVICE_ID Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:0	device_id	RW	0x0	Device ID. For default value refer to Product Identification. This field is write-able so it may be configured from OTP.

3.1.3 DEVICE_REV

Font ID, Analog Revision, and Digital Revision.

DEVICE_REV Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:13	reserved	RO	0x0	Reserved
12:8	font_id	RO	0x1	Font ID. Font ID to distinguish die variants. Decode as follows: 0x0 = Font 0 0x1 = Font 1
7:4	ana_rev	RO	0x2	Hardware analog revision. Analog revision. Decode as follows: 0x1 = Test vehicle 0x2 = Rev A
3:0	dig_rev	RO	0x2	Hardware digital revision. Digital revision. Decode as follows: 0x1 = Test vehicle 0x2 = Rev A

3.1.4 DEVICE_PGM

Device Dash Code.

DEVICE_PGM Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:0	dash_code	RW	0x0	Dash code. Decimal value assigned by IDT to identify the user configuration loaded in OTP at the factory. This field is write-able and is configured from the OTP common configuration programmed at the factory. 0x0 = No user configurations are programmed at the factory

3.1.5 DEVICE_CNFG

Device Configuration Settings.

DEVICE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:29	reserved	RO	0x0	Reserved
28:27	vco_cal_timer	RW	0x1	Timeout timer value during VCO Calibration state. Sets the timeout timer allowed for VCO Calibration before that state times out in the startup process. If this is not set correctly to a value longer than the expected VCO calibration time, vco_timeout error can occur. 0x0 = 4 ms 0x1 = 8 ms 0x2 = 16 ms 0x3 = 32 ms

DEVICE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
26	float_vddo6	RW	0x0	Float VDDO6 Supply. Active high bit to enable Iref and Ibias to output divider LDO, output bank LDO, output divider IOD0 and output driver OUT11/11B in VDDO6 domain. iod_rst for IOD0 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use IOD0 or OUT11/11B from any divider. Must be set to 0x1 (disabled) when the VDDO6 pin floats. 0x0 = reference currents enabled 0x1 = reference currents disabled
25	float_vddo5	RW	0x0	Float VDDO5 Supply. Active high bit to disable Iref and Ibias to output divider LDO, output bank LDO, output divider IOD1 and output driver OUT10/10B in VDDO5 domain. iod_rst for IOD1 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use IOD1 or OUT10/10B from any divider. Must be set to 0x1 (disabled) when the VDDO5 pin floats. 0x0 = reference currents enabled 0x1 = reference currents disabled
24	float_vddo4	RW	0x0	Float VDDO4 Supply. Active high bit to disable Iref and Ibias to output divider LDO, output bank LDO, output divider HPFOD2 and output driver OUT/OUTB 8,9 in VDDO4 domain. hpfod_rst for HPFOD2 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use HPFOD2 or any of OUT/OUTB 8,9 from any divider. Must be set to 0x1 (disabled) when the VDDO4 pin floats. 0x0 = reference currents enabled 0x1 = reference currents disabled
23	float_vddo3	RW	0x0	Float VDDO3 Supply. Active high bit to disable Iref and Ibias to output divider LDO, output bank LDO, output divider HPFOD1 and output driver OUT/OUTB 4-7 in VDDO3 domain. hpfod_rst for HPFOD1 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use HPFOD1 or any of OUT/OUTB 4-7 from any divider. Must be set to 0x1 (disabled) when the VDDO3 pin floats. 0x0 = reference currents enabled 0x1 = reference currents disabled
22	float_vddo2	RW	0x0	Float VDDO2 Supply. Active high bit to disable Iref and Ibias to output divider LDO, output bank LDO, output divider HPFOD0 and output driver OUT/OUTB 2,3 in VDDO2 domain. hpfod_rst for HPFOD0 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use HPFOD0 or any of OUT/OUTB 2,3 from any divider. Must be set to 0x1 (disabled) when the VDDO2 pin floats. 0x0 = reference currents enabled 0x1 = reference currents disabled
21	float_vddo1	RW	0x0	Float VDDO1 Supply. Active high bit to disable Iref and Ibias to output divider LDO, output bank LDO, output divider LPFOD1 and output driver OUT1/1B in VDDO1 domain. lpfod_rst for LPFOD1 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use LPFOD1 or OUT1/1B from any divider. Must be set to 0x1 (disabled) when the VDDO1 pin floats. 0x0 = reference currents enabled 0x1 = reference currents disabled

DEVICE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
20	float_vddo0	RW	0x0	<p>Float VDDO0 Supply. Active high bit to disable Iref and Ibias to output divider LDO, output bank LDO, output divider LPFOD0 and output driver OUT0/0B in VDDO0 domain. Ipfod_rst for LPFOD0 must be set to '1' if this bit is set to '1'. Only set this bit to '1' for configurations that do not use LPFOD0 or OUT0/0B from any divider.</p> <p>Must be set to 0x1 (disabled) when the VDDO0 pin floats.</p> <p>0x0 = reference currents enabled 0x1 = reference currents disabled</p>
19:16	sync_dis_wait	RW	0x2	<p>Divider Synchronization Output Clock Disable Wait Time. During the divider synchronization procedure, after deasserting the output enable to the affected output drivers, the control logic waits for this period of time before stopping the clocks and synchronizing the dividers. This must be set longer than the period of the slowest output clock, and longer than the SSC modulation interval (if enabled).</p> <p>0x0 = 1us 0x1 = 2us 0x2 = 4us 0x3 = 8us 0x4 = 16us 0x5 = 32us 0x6 = 64us 0x7 = 128us 0x8 = 256us 0x9 = 512us</p>
sync_dis_wait (continued)				<p>0xA = 1024us 0xB = 2048us 0xC = 4096us</p>
15	digldo_cnf	RW	0x0	<p>Digital LDO voltage select. Selects the digital LDO voltage level. This setting is intended for test purposes only. This is controlled by scan_control[6] during scan mode.</p> <p>0x0 = 1.25V 0x1 = 1.32V</p>
14:12	xo_delay	RW	0x0	<p>Crystal Startup Delay. Selects the wait time for the XO during the startup sequence. The default setting of 1 ms should be sufficient for all crystals. This setting is intended for debug purposes only.</p> <p>0x0 = 1 ms 0x1 = 2.5 ms 0x2 = 5 ms 0x3 = 7.5 ms 0x4 = 10 ms 0x5 = 0.5 ms 0x6 = 15 ms 0x7 = (10 us, for simulation speedup)</p>

DEVICE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
11:8	static_csel2	RW	0x2	Static Configuration Select Bit 2. Selects the GPIO pin or fixed value used for static configuration select bit index 2. 0x0 = GPIO0 0x1 = GPIO1 0x2 = GPIO2 0x3 = GPIO3 0x4 = GPIO4 0x5 = GPIO5 0x6 = GPIO6 0xE = No pin selected, treated as 0 0xF = No pin selected, treated as 1
7:4	static_csel1	RW	0x1	Static Configuration Select Bit 1. Selects the GPIO pin or fixed value used for static configuration select bit index 1. 0x0 = GPIO0 0x1 = GPIO1 0x2 = GPIO2 0x3 = GPIO3 0x4 = GPIO4 0x5 = GPIO5 0x6 = GPIO6 0xE = No pin selected, treated as 0 0xF = No pin selected, treated as 1
3:0	static_csel0	RW	0x0	Static Configuration Select Bit 0. Selects the GPIO pin or fixed value used for static configuration select bit index 0. 0x0 = GPIO0 0x1 = GPIO1 0x2 = GPIO2 0x3 = GPIO3 0x4 = GPIO4 0x5 = GPIO5 0x6 = GPIO6 0xE = No pin selected, treated as 0 0xF = No pin selected, treated as 1

3.1.6 CNFG_LOCK

OTP Lock Control.

CNFG_LOCK Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:1	reserved	RO	0x0	Reserved
0	otp_lock	RW1S	0x0	OTP Lock. Prevents OTP programming when set to 1. This bit cannot be cleared by software. It is reset when the device is power cycled. Not used for TV.

3.1.7 SW_RESET

Software Reset Bits.

SW_RESET Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:12	reserved	RO	0x0	Reserved
11	ssc_sw_rst	RW	0x0	Spread Spectrum Engine Software reset. The Spread Spectrum block is held in reset while this bit is set to 1. This bit will reset the divider to HPFOD0 and HPFOD1. Do not set this bit to 1 while HPFOD0 or HPFOD1 are in use.
10	xtalsw_sw_rst	RW	0x0	Crystal switching block Software reset. The Crystal switching block is held in reset while the corresponding bit is set to 1.
9:5	reserved	RO	0x0	Reserved
4	freqmon_sw_rst	RW	0x0	Output Frequency Monitor Software reset. The Output Frequency Monitor is held in reset while the corresponding bit is set to 1.
3	st_mon_sw_rst	RW	0x0	Crystal Short Term Monitor Software reset. The Crystal Short Term Monitor is held in reset while this corresponding bit is set to 1.
2	xtal_ppm_sw_rst	RW	0x0	Crystal PPM Monitor Software reset. The Crystal PPM Monitor is held in reset while this corresponding bit is set to 1.
1:0	losmon_sw_rst	RW	0x0	Crystal LOS Monitor Software reset. A Crystal LOS Monitor is held in reset while the corresponding bit is set to 1. Bit [1] = Crystal 1 LOS Monitor Bit [0] = Crystal 0 LOS Monitor

3.1.8 FREQ_WINDOW_CNFG

Frequency Monitor Window Configuration.

FREQ_WINDOW_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:24	reserved	RO	0x0	Reserved
23:16	freq_slow_window	RW	0x0	Frequency Monitor Slow Window. Sets the duration of the slow frequency monitoring window, counted in fast frequency monitoring windows. Each frequency monitor independently selects the slow or fast window with freq_window_sel.
15:0	freq_fast_window	RW	0x0	Frequency Monitor Fast Window. Sets the duration of the fast frequency monitoring window, counted in crystal clock cycles. Each frequency monitor independently selects the slow or fast window with freq_window_sel. Minimum size for operation is 2.

3.1.9 FREQ_CLOCK_SEL

Output Frequency Monitor Control.

FREQ_CLOCK_SEL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:25	reserved	RO	0x0	Reserved

FREQ_CLOCK_SEL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
24	fm_shutdown	RW	0x0	Shutdown for output frequency monitoring. When set to 0x0, monitoring is enabled using the freq_out_sel and freq_outb_sel bits. When set to 0x1, all output frequency monitoring is disabled. 0x0 = enabled 0x1 = disabled
23:12	freq_outb_sel	RW	0x0	Complementary Output Clock Frequency Monitor Selection. Selects the complementary clock outputs (OUTxB) to monitor with the frequency monitors. The frequency monitor for the output clock's bank must be enabled and configured according to the expected frequency. If a freq_outb_sel bit is disabled (set to 0), that clocks freq_outb_sts will be set to '0'. Bit [11] = Enable Complementary Output Clock 11 frequency monitoring ... Bit [0] = Enable Complementary Output Clock 0 frequency monitoring
11:0	freq_out_sel	RW	0x0	Output Clock Frequency Monitor Selection. Selects the true clock outputs (OUTx) to monitor with the frequency monitors. The frequency monitor for the output clock's bank must be enabled and configured according to the expected frequency. If a freq_out_sel bit is disabled (set to 0), that clocks freq_out_sts will be set to '0'. Bit [11] = Enable Output Clock 11 frequency monitoring ... Bit [0] = Enable Output Clock 0 frequency monitoring

3.1.10 MISC_CNFG

Configuration Settings.

MISC_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:26	reserved	RO	0x0	Reserved
25	sel_orig_ref_clock	RW	0x0	Controls which reference clock is used for VCO calibration and the frequency monitor. When set to 0x0, the vco calibration and output frequency monitor use the resampled reference clock. When set to 0x1, the vco_calibration and output frequency monitor uses the original non-resampled reference clock. This should be used if the reference clock will be faster than the maximum supported XTAL of 62.5MHz. 0x0 = resampled reference clock 0x1 = original reference clock
24	rstcon_enable_events	RW	0x0	Enable events during boot. When set, this bit allows the events to be latched during the boot procedure. When cleared (default behavior), event latching is disabled during boot and only is allowed after the reset procedure has finished. 0x0 = latching enable after boot 0x1 = latching enabled during boot
23:19	dcd_slow_update_rate	RW	0x10	DCD Calibration Slow Filter Update Rate. The DCD calibration slow filter mode update rate (in Hz) is: $1e6 \text{ Hz} / (2^{\text{dcd_slow_update_rate}})$ The valid range is 0 (1 MHz) to 20 (approximately 1 Hz). The default setting is ~15kHz. This setting is common to all FODs.

MISC_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
18:16	dcd_slow_start_delay	RW	0x5	DCD Calibration Slow Filter Start Delay. When dcd_slow_en is set to 1, this setting specifies a delay before the slow filter mode is enabled internally, following the end of accelerated calibration. 0x0 = 0ms (no delay, enabled immediately) 0x1 = 1 ms 0x2 = 10 ms 0x3 = 100 ms 0x4 = 1 s 0x5 = 10 s 0x6 = 100 s
15:14	out_startup	RW	0x0	Output / monitoring disable on startup until PLL locks. Controls whether the clock output drivers / clock monitoring are disabled until the APLL locks during the startup sequence. 0x0: Clock output drivers / clock monitoring are disabled until APLL lock asserts 0x2: Clock output drivers /clock monitoring are not disabled by APLL lock status 0x0 = disabled until APLL lock 0x2 = unaffected by APLL lock status
13:8	reserved	RO	0x0	Reserved
7	ssc_sync	RW	0x0	Spectrum Spreading Sync. When the two SSC engines have the same modulation frequency, setting this bit to 1 aligns the phase of SSC 1 to SSC 0. Refer to ssc_en for restrictions on enabling the SSCs when ssc_sync is set to 1. Note: This field was named ssc_share in VC7. 0x0 = SSC 1 operates independently 0x1 = SSC 1 phase is aligned to SSC 0
6	xtal_sel_pri	RW	0x0	Automatic Crystal Selection Priority. Sets the relative priority of the two crystals for automatic selection on device startup when both crystals are valid. 0x0 = Crystal 0 has priority over crystal 1 0x1 = Crystal 1 has priority over crystal 0
5	reserved	RO	0x0	Reserved
4:3	xtal_sel_mode	RW	0x2	Crystal Selection Mode. Controls how the APLL reference crystal is selected. Automatic mode (option 0x2) is based on Crystal LOS and short term monitors and GPIO pin if in gpio_func 0x6 mode 0x0 = Force primary crystal 0x1 = Force backup crystal 0x2 = Automatic
2	reserved	RO	0x0	Reserved

MISC_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
1	csr_sig_err_mode	RW	0x0	<p>CSR Signature Check Error Mode. Determines the behavior when the CSR signature check detects an error.</p> <p>0x0: Set csr_sig_fail. The csr_sig_fail_fault_en bit would typically be set to 1, allowing the device to enter the safe state and assert the FAULT output.</p> <p>0x1: Set csr_sig_reload. The outputs are disabled, the user configuration is reloaded from OTP (with the exception of certain register fields), and the normal power-up sequence begins. The csr_sig_reload_int_en bit would typically be set to 1 so that the INT output asserts to notify the system.</p> <p>0x0 = Set csr_sig_fail 0x1 = Set csr_sig_reload</p>
0	csr_sig_timer	RW	0x0	<p>CSR Signature Check Timer Interval. Determines the interval at which the device self-checks the CSR signature.</p> <p>0x0 = Disabled 0x1 = 10ms</p>

3.1.11 DIG_POST_CNFG

Digital POST Disable Controls.

DIG_POST_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:24	reserved	RO	0x0	Reserved
23	csr_sig_post_dis	RW	0x0	CSR Signature Monitor POST Disable. When 1, disables CSR Signature Monitor Power on Self Test.
22	dual_xtal_fail_post_dis	RW	0x0	Dual XTAL Fail POST Disable. When 1, disables Dual XTAL failure Power on Self Test. Both XTALs must be enabled and POST_LOS_THRESH register must be programmed correctly to enable this POST test.
21	xtal_sw_post_dis	RW	0x0	XTAL Switching POST Disable. When 1, disables XTAL switching Power on Self Test. Both XTALs must be enabled and POST_LOS_THRESH register must be programmed correctly to enable this POST test.
20:9	freq_post_dis	RW	0x0	Output Frequency Monitor Fault Injection POST Disable. When 1, disables Frequency Monitor Power on Self Test for the given output. Enable this POST test only for correctly configured outputs/outputs that have monitoring enabled in FREQ_CLOCK_SEL. freq_post_dis must be set to '1' for any outputs where both freq_out_sel = 0 and freq_outb_sel = 0 unless all 12 freq_out_sel and freq_outb_sel bits are 0- then the Frequency Monitor Power on Self Test will be skipped automatically. POST_FREQMON_CNFG register must be programmed correctly to enable this POST test.
8	xtal1_st_err_post_dis	RW	0x0	XTAL1 Short Term POST Disable. When 1, disables XTAL1 Short Term Monitor Power on Self Test. Both XTALs must be enabled and ST_CNFG register must be programmed correctly to enable this POST test.
7	xtal0_st_err_post_dis	RW	0x0	XTAL0 Short Term POST Disable. When 1, disables XTAL0 Short Term Monitor Power on Self Test. Both XTALs must be enabled and ST_CNFG register must be programmed correctly to enable this POST test.

DIG_POST_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
6	xtal_ppm_err_post_dis	RW	0x0	XTAL PPM Error POST Disable. When 1, disables XTAL PPM Error Power on Self Test. Both XTALs must be enabled and POST_PPM_CNFG register must be programmed correctly to enable this POST test.
5	xtal_ppm_warn_post_dis	RW	0x0	XTAL PPM Warning POST Disable. When 1, disables XTAL PPM Warning Power on Self Test. Both XTALs must be enabled and POST_PPM_CNFG register must be programmed correctly to enable this POST test.
4	los1_post_dis	RW	0x0	XTAL1 LOS POST Disable. When 1, disables XTAL1 Loss of Signal Power on Self Test. XTAL1 must be enabled and POST_LOS_THRESH register and LOSMON_CNFG register must be programmed correctly to enable this POST test.
3	los0_post_dis	RW	0x0	XTAL0 LOS POST Disable. When 1, disables XTAL0 Loss of Signal Power on Self Test. XTAL0 must be enabled and POST_LOS_THRESH register and LOSMON_CNFG register must be programmed correctly to enable this POST test.
2	apll_lol_post_dis	RW	0x0	APLL LOL POST Disable. When 1, disables APLL Loss of Lock Power on Self Test. POST_APLL_FB_DIV_LOL register must be programmed correctly to enable this POST test.
1	lbist_dis	RW	0x1	Digital LBIST Disable. When 1, disables digital logic BIST to run at startup. LBIST_SIGNATURE.lbist_signature must be set correctly in OTP for the length of time LBIST will run if lbist_dis is set to 0 in OTP.
0	dig_post_dis	RW	0x0	POST Disable. When 1, disables all Digital Power on Self Test to run when Power on self test is triggered including anything enabled in DIG_POST_CNFG.

3.1.12 ANA_POST_CNFG

Analog POST Disable Controls.

ANA_POST_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:21	reserved	RO	0x0	Reserved
20	bias_cal_ana_post_exclude	RW	0x0	Bias Calibration Exclude for Analog POST. When 1, excludes the Bias Calibration pass/fail status in the Analog POST status.
19	vco_cal_ana_post_exclude	RW	0x0	VCO Calibration Exclude for Analog POST. When 1, excludes the VCO Calibration pass/fail status in the Analog POST status.
18	ana_post_ldo_low_fault_det_dis	RW	0x0	Analog LDO Low Fault Detection POST Disable. When 1, disables Analog LDO Low Fault Detection POST to run when Power on Self Test is triggered.
17	ana_post_ldo_in_range_det_dis	RW	0x0	Analog LDO In Range Detection POST Disable. When 1, disables Analog LDO In Range Detection POST to run when Power on Self Test is triggered.
16	ana_post_ldo_high_fault_det_dis	RW	0x0	Analog LDO High Fault Detection POST Disable. When 1, disables Analog LDO High Fault Detection POST to run when Power on Self Test is triggered.
15	ana_post_ref_x1_ldo_dis	RW	0x0	Analog Reference X1 LDO POST Disable. When 1, disables Analog X1 Reference LDO POST to run when Power on Self Test is triggered.

ANA_POST_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
14	ana_post_ref_x0_ldo_dis	RW	0x0	Analog Reference X0 LDO POST Disable. When 1, disables Analog X0 Reference LDO POST to run when Power on Self Test is triggered.
13	ana_post_apll_cp_ldo_dis	RW	0x0	Analog APLL CP LDO POST Disable. When 1, disables Analog APLL CP LDO POST to run when Power on Self Test is triggered.
12	ana_post_apll_pfd_ldo_dis	RW	0x0	Analog APLL PFD LDO POST Disable. When 1, disables Analog APLL PFD LDO POST to run when Power on Self Test is triggered.
11	ana_post_apll_vco_ldo_dis	RW	0x0	Analog APLL VCO LDO POST Disable. When 1, disables Analog APLL VCO LDO POST to run when Power on Self Test is triggered.
10	ana_post_od_iod0_ldo_dis	RW	0x0	Analog IOD0 Output Divider LDO POST Disable. When 1, disables Analog IOD0 Output Divider LDO POST to run when Power on Self Test is triggered.
9	ana_post_od_iod1_ldo_dis	RW	0x0	Analog IOD1 Output Divider LDO POST Disable. When 1, disables Analog IOD1 Output Divider LDO POST to run when Power on Self Test is triggered.
8	ana_post_od_hpfod2_ldo_dis	RW	0x0	Analog HPFOD2 Output Divider LDO POST Disable. When 1, disables Analog HPFOD2 Output Divider LDO POST to run when Power on Self Test is triggered.
7	ana_post_od_hpfod1_ldo_dis	RW	0x0	Analog HPFOD1 Output Divider LDO POST Disable. When 1, disables Analog HPFOD1 Output Divider LDO POST to run when Power on Self Test is triggered.
6	ana_post_od_hpfod0_ldo_dis	RW	0x0	Analog HPFOD0 Output Divider LDO POST Disable. When 1, disables Analog HPFOD0 Output Divider LDO POST to run when Power on Self Test is triggered.
5	ana_post_od_lpfod1_ldo_dis	RW	0x0	Analog LPFOD1 Output Divider LDO POST Disable. When 1, disables Analog LPFOD1 Output Divider LDO POST to run when Power on Self Test is triggered.
4	ana_post_od_lpfod0_ldo_dis	RW	0x0	Analog LPFOD0 Output Divider LDO POST Disable. When 1, disables Analog LPFOD0 Output Divider LDO POST to run when Power on Self Test is triggered.
3	ana_post_dig_fod_ldo_dis	RW	0x0	Analog Digital FOD LDO POST Disable. When 1, disables Analog Digital FOD LDO POST to run when Power on Self Test is triggered.
2	ana_post_dig_apll_ldo_dis	RW	0x0	Analog Digital APLL Divider LDO POST Disable. When 1, disables Analog Digital APLL Divider LDO POST to run when Power on Self Test is triggered.
1	ana_post_dig_block_ldo_dis	RW	0x0	Analog Digital Block LDO POST Disable. When 1, disables Analog Digital Block LDO POST to run when Power on Self Test is triggered.
0	ana_post_dis	RW	0x0	Analog POST Disable. When 1, disables all analog LDO POST to run when Power on Self Test is triggered.

3.1.13 POST_FREQMON_CNFG

POST Output Frequency Monitor Configuration.

POST_FREQMON_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:20	post_freq_window	RW	0x1F4	POST Monitor Fast Window. Sets the duration of the frequency monitoring window, counted in crystal clock cycles during POST. During POST the output dividers are used internally and forced to divide by 100 (example 100 MHz for 10 GHz VCO). Minimum size for operation is 2. This register must be set correctly for POST to pass. 10us duration required.
19:10	post_freq_max_thresh	RW	0x1FF	POST Frequency Monitor Max Threshold. This gives the number of rising edges of the monitored clock at the end of a monitoring window during POST. Set for divider of 100 during POST. This register field or post_freq_min_threshold must be set to a value to cause a frequency error out of range for POST to pass. Set to 0 to disable the frequency monitor POST check.
9:0	post_freq_min_thresh	RW	0xF	POST Frequency Monitor Min Threshold. This gives the number of rising edges of the monitored clock at the end of a monitoring window during POST. Set for divider of 100 during POST. This register field or post_freq_max_threshold must be set to a value to cause a frequency out of range error for POST to pass.

3.1.14 POST_APLL_FB_DIV_LOL

POST APLL LOL Feedback Divider Integer Setting.

POST_APLL_FB_DIV_LOL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:12	reserved	RO	0x0	Reserved
11:10	post_apll_lock_timer	RW	0x2	POST APLL Lock Timer. Controls the digital debounce interval for the lock indication for the APLL during POST. This duration is a function of the system clock cycles. 0x0 = 5 cycles of the system clock 0x1 = 285 cycles of the system clock 0x2 = 2850 cycles of the system clock 0x3 = 28500 cycles of the system clock.
9:0	post_apll_fb_div_lol	RW	0x91	POST APLL Feedback Divider Integer designed to cause APLL LOL. POST APLL feedback divider integer value error value to force a Loss-of-Lock- Recommend adding 40 to correct apll_fb_div value-adjust as needed based on correct value.

3.1.15 POST_PPM_CNFG

POST Crystal PPM Monitor Configuration.

POST_PPM_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:8	post_ppm_err_thresh	RW	0x3	POST Crystal PPM Monitor Error Threshold. If the difference between the crystal counters at the end of the monitoring window exceeds this threshold, then the xtal_ppm_err bit is set. The granularity is 2 ppm/lsb. This register must be set correctly for POST to pass. Set to 0 to disable the check.
7:0	post_ppm_warn_thresh	RW	0x1	POST Crystal PPM Monitor Warning Threshold. If the difference between the crystal counters at the end of the monitoring window exceeds this threshold, but does not exceed ppm_err_thresh, then the xtal_ppm_warn bit is set. The granularity is 2 ppm/lsb. This register must be set correctly for POST to pass. Set to 0 to disable the check.

3.1.16 POST_LOS_THRESH

POST LDO Bias Fault Detection Settings.

POST_LOS_THRESH Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	post_los_thresh_scale	RW	0x0	Scaling applied to LOSMON_CNFG.los_thresh during POST. Scales LOSMON_CNFG.los_thresh to allow for LOS check with unlocked APLL during POST. 0x0 = Increase value by 25% up to max 0x1 = Increase value by 50% up to max
6:0	post_los_thresh_det	RW	0x1	LOS Threshold to generate LOS detection for POST. Sets the maximum number of VCO calibration clock (593MHz to 669MHz) cycles from any rising edge of the crystal clock to the next rising edge, and from any falling edge to the next falling edge. If this threshold is reached before the next edge occurs in the same direction, then the monitor's los_sts and losX_evt bits are set; los_sts will remain set until the next crystal rising or falling edge occurs. Set to a value to cause LOS detection to trigger in POST (recommended 0x1). This register must be set correctly for POST to pass. LOSMON_CNFG.los_thresh must also be programmed correctly for POST to pass.

3.2 SSI

I2C registers.

Table 4. SSI Register Index

Offset (Hex)	Register Module Base Address: 0x40	
	Register Name	Register Description
0x0	I2C_FLTR_CNFG	I2C Filter Settings
0x1	I2C_TIMING_CNFG	I2C Timing Configuration
0x2	I2C_ADDR_CNFG	I2C Address Configuration
0x3	SSI_GLOBAL_CNFG	I2C Global Configuration

3.2.1 I2C_FLTR_CNFG

I2C Filter Settings.

I2C_FLTR_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	reserved	RO	0x0	Reserved
3:0	i2c_spike_ftr	RW	0x3	I2C digital spike filter duration. Controls the duration of the digital spike filters on the SCL and SDA inputs, specified in number of system clock cycles (16.7 ns). 0 disables filtering.

3.2.2 I2C_TIMING_CNFG

I2C Timing Configuration.

I2C_TIMING_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	i2c_sda_high_hold	RW	0x2	I2C transmit one bit delay. Delays transmission of '1' value by this number of 133ns periods (8 system clock cycles).
3:0	i2c_sda_low_hold	RW	0x2	I2C transmit zero bit delay. Delays transmission of '0' value by this number of 133ns periods (8 system clock cycles). Allows data-hold-times on strongly pulled-down '0' value bits to be set to match data-hold-times on weakly (resistively) pulled-up '1' value bits.

3.2.3 I2C_ADDR_CNFG

I2C Address Configuration.

I2C_ADDR_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	reserved	RO	0x0	Reserved
6:0	i2c_addr	RW	0x9	I2C device address. Sets I2C device address that the SSI will acknowledge and accept accesses on.

3.2.4 SSI_GLOBAL_CNFG

I2C Global Configuration.

SSI_GLOBAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:6	reserved	RO	0x0	Reserved
5	i2c_crc_en	RW	0x0	I2C CRC Enable. Enables the I2C CRC check. 0x0 = CRC disabled 0x1 = CRC enabled

SSI_GLOBAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
4:3	sda_drv	RW	0x0	I2C Drive Strength. Selects the operating speed of the interface when configured for I2C mode. Only the output driver slew rate is affected by this setting (higher settings means higher drive strength). The I2C master must provide the appropriate SCL frequency and other timing requirements according to the selected speed. Drive strength increases as this setting increases. 0x0: 1.8V Standard mode (100 kHz) or 2.5V/3.3V standard (100kHz) and Fast mode (400kHz) 0x1: 1.8V Fast mode (400 kHz) 0x2: reserved 0x3: 1.8V/2.5V/3.3V Fast mode plus (1 MHz) 0x0 = 100kHz (1.8V), 400kHz (2.5V/3.3V) 0x1 = 400kHz (1.8V) 0x3 = 1MHz (1.8V/2.5V/3.3V)
2	ssi_addr_size	RW	0x0	SSI address size. When '0' the SSI expects 1-byte CSR addresses; when '1' the SSI expects 2-byte CSR addresses. Upper address bits are taken from the SSI's page register to create a full 16-bit CSR address. 0x0 = 1-byte address 0x1 = 2-byte address
1:0	ssi_enable	RW	0x1	SSI mode. Selects the serial interface mode. 0x0 = SSI is disabled 0x1 = SSI is in I2C mode

3.3 XO

XO control registers.

Table 5. XO Register Index

Offset (Hex)	Register Module Base Address: 0x48	
	Register Name	Register Description
0x0	XO_CNFG	XO Configuration

3.3.1 XO_CNFG

XO Configuration.

XO_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:30	reserved	RO	0x0	Reserved
29	xo_ib_h_div_setb	RW	0x1	XO / Input Buffer High Frequency Divider Set. When cleared, the XO/IB high frequency divider is held in set mode (bit is active low).
28:24	xo_ib_h_div	RW	0x0	XO / Input Buffer high frequency divide ratio. Divide by 2 to 31. Bypass if set to 0. 1 is reserved.

XO_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
23:22	en_gain	RW	0x1	XO gain boosting control. Selects the number of gain boosting amplifiers enabled during startup. 0x0 = Gain boosting amplifiers are disabled 0x1 = One parallel amplifier is enabled 0x2 = Two parallel amplifiers are enabled 0x3 = All three parallel amplifiers are enabled
21:16	en_cap_x2	RW	0x28	XO capacitance at X2 terminal. Controls the internal capacitance applied at the X2 terminal (XOUT_REFINb device pin)/connected to the integrated crystal. The capacitance rises monotonically in steps of 0.375fF from 0pF to 24pF as the control setting increases from 0x00 to the maximum of 0x3F. This must be set to 0 when sel_ib_xo is set to 0.
15	reserved	RO	0x0	Reserved
14	xo_buff_dis	RW	0x0	XO buffer disable. Forces the XO buffer to the core logic to be disabled. This setting is intended for debug purposes only. When the XO buffer is enabled (option 0x0), it is controlled by the hardware. It is enabled during the startup sequence and remains enabled until the device is power cycled. 0x0 = controlled by hardware 0x1 = disabled
13:8	en_cap_x1	RW	0x28	XO capacitance at X1 terminal. Controls the internal capacitance applied at the X1 terminal (XIN_REFIN device pin)/connected to the integrated crystal. The capacitance rises monotonically in steps of 0.375fF from 0pF to 24pF as the control setting increases from 0x00 to the maximum of 0x3F. This must be set to 0 when sel_ib_xo is set to 0.
7	xo_en_hyst	RW	0x1	Hysteresis enable for monitor path. Writing this bit to a '1' adds hysteresis to reference monitor path. 0x0 = Hysteresis disabled for monitor path 0x1 = Hysteresis enabled for monitor path
6:4	xo_res	RW	0x4	XO Resistor Configuration. Series resistance array control for limiting driving power level.
3	xo_ib_en_dc_bias	RW	0x0	Input Buffer internal DC bias enable. When the input buffer clock input signal is AC-coupled external to the device, the internal DC bias voltage must be enabled. When internal DC bias is disabled (option 0x0), the input signal is DC-coupled. When it is enabled (option 0x1), the input signal is AC-coupled. 0x0 = disabled 0x1 = enabled
2	sel_ib_xo	RW	0x1	XO / Input Buffer select. Selects the mode of the XO / Input Buffer. 0x0 = Input buffer 0x1 = XO

XO_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
1	xo_ib_cmos_sel	RW	0x0	Input Buffer CMOS / differential select. Configures the input buffer for single-ended CMOS or differential input signal. 0x0 = differential 0x1 = CMOS
0	xo_ib_p_n_diff_sel	RW	0x1	Input Buffer PMOS / NMOS select. Configures the input buffer according to the common mode voltage of the provided input signal. 0x0: PMOS input pair is enabled (low common mode voltage) 0x1: NMOS input pair is enabled (higher common mode voltage) 0x0 = PMOS 0x1 = NMOS

3.4 SYSDIV

System clock registers.

Table 6. SYSDIV Register Index

Offset (Hex)	Register Module Base Address: 0x50	
	Register Name	Register Description
0x0	SYS_DIV_INT	System Clock Divider Setting
0x1	COUNTER_1US	One Microsecond Counter Setting

3.4.1 SYS_DIV_INT

System Clock Divider Setting.

SYS_DIV_INT Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:5	reserved	RO	0x0	Reserved
4:0	sys_div_int	RW	0xC	Quadruple System Clock Divide Ratio. The quadruple system clock divide integer value must be set to produce a frequency between 180MHz and 280MHz, divided down from the APLL VCO frequency divided by 4. This clock is divided by 2 to generate the double system clock, and further divided by 2 to generate the system clock. The frequency picked will have side effects on various calculations done in other blocks (LOSMON, OTP). Normally expected to be between 210MHz and 240MHz, giving a system clock frequency between 52.5MHz and 60MHz. The minimum valid value for this field is 8. Note: The count_1us register field must be programmed according to the system clock frequency. **Note-scan_control3[12:8] must be set to the same value as this register if Logic BIST will be run.

3.4.2 COUNTER_1US

One Microsecond Counter Setting.

COUNTER_1US Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:0	count_1us	RW	0x3B	One microsecond counter interval. In system clock cycles, minus 1. This configures counters in the OTP.

3.5 XTALMON

Crystal monitoring registers.

Table 7. XTALMON Register Index

Offset (Hex)	Register Module Base Address: 0x58	
	Register Name	Register Description
0x0	ST_CNFG	Crystal Short Term Monitor Configuration
0x4	PPM_CNFG	Crystal PPM Monitor Configuration

3.5.1 ST_CNFG

Crystal Short Term Monitor Configuration.

ST_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:24	st_max_thresh	RW	0x0	Crystal Short Term Monitor Max Threshold. If the absolute value of the difference between one crystal counter and the feedback counter at the end of a monitoring window exceeds this threshold, and the absolute value of the difference between the other crystal counter and the feedback counter is less than st_min_thresh, then either the xtal0_st_err or xtal1_st_err bit is set depending on whether crystal 0 or 1 exceeded st_max_thresh, respectively. The failing crystal's xtal_invalid bit is set to 1 while the frequency remains outside the threshold. Setting this threshold to 0 will disable the short term monitor.
23:16	st_min_thresh	RW	0x0	Crystal Short Term Monitor Min Threshold. Refer to st_max_thresh.
15:12	reserved	RO	0x0	Reserved
11:0	st_window	RW	0x0	Crystal Short Term Monitor Window. Sets the short term monitor window duration, counted in counted in VCO calibration clock (VCO clock divided by 16, approximately 592MHz to 669MHz) cycles. Set to 0 to disable the short term monitor.

3.5.2 PPM_CNFG

Crystal PPM Monitor Configuration.

PPM_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:8	ppm_err_thresh	RW	0x0	Crystal PPM Monitor Error Threshold. If the difference between the crystal counters at the end of the monitoring window exceeds this threshold, then the xtal_ppm_err bit is set. The granularity is 2 ppm/lb. Set to 0 to disable the check.
7:0	ppm_warn_thresh	RW	0x0	Crystal PPM Monitor Warning Threshold. If the difference between the crystal counters at the end of the monitoring window exceeds this threshold, but does not exceed ppm_err_thresh, then the xtal_ppm_warn bit is set. The granularity is 2 ppm/lb. Set to 0 to disable the check.

3.6 LOSMON

LOS monitor registers.

Table 8. LOSMON Register Index

Offset (Hex)	Register Module Base Address: 0x60	
	Register Name	Register Description
0x0	LOSMON_CNFG	LOS Monitor and Crystal Selection

3.6.1 LOSMON_CNFG

LOS Monitor and Crystal Selection.

LOSMON_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:12	reserved	RO	0x0	Reserved
11	xtal_disable	RW	0x0	APLL Reference Clock Selection Disable. Controls whether this crystal may be selected as the APLL reference clock. When enabled (option 0x0), the crystal may be selected, subject to qualification by the Loss-of-Signal and Short Term monitors, and prioritization according to xtal_sel_pri. When disabled (option 0x1), the crystal cannot be selected and xtal_invalid is set to 1. 0x0 = enabled 0x1 = disabled
10	los_fail_mask	RW	0x0	LOS Monitor Failure Mask. Masks the LOS monitor status contribution to xtal_invalid. 0x0 = los_sts contributes to xtal_invalid 0x1 = los_sts does not contribute to xtal_invalid

LOSMON_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
9:7	reserved	RO	0x0	Reserved
6:0	los_thresh	RW	0x0	<p>LOS Threshold. Sets the maximum number of VCO calibration clock (593MHz to 669MHz) cycles from any rising edge of the crystal clock to the next rising edge, and from any falling edge to the next falling edge. If this threshold is reached before the next edge occurs in the same direction, then the monitor's los_sts and losX_evt bits are set; los_sts will remain set until the next crystal rising or falling edge occurs.</p> <p>This ratio can be calculated by the VCO calibration clock frequency (which is the VCO clock frequency/16) divided by the crystal clock frequency.</p> <p>For fractional values, of this ratio, this value should be rounded up to the next whole number for programming los_thresh and for integer (or near integer with fraction>0.9) values of this ratio, 1 should be added to the value for programming los_thresh.</p> <p>Set to 0 to disable the LOS monitor.</p>

3.7 FREQMON

Bank output frequency monitor registers.

Table 9. FREQMON Register Index

Offset (Hex)	Register Module Base Address: 0x70	
	Register Name	Register Description
0x0	FREQMON_THRESH	Output Frequency Monitor Thresholds

3.7.1 FREQMON_THRESH

Output Frequency Monitor Thresholds.

FREQMON_THRESH Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
63:49	reserved	RO	0x0	Reserved
48	freq_window_sel	RW	0x0	<p>Frequency Monitor Window Selection. Selects the fast or slow monitoring window. The slow window should be used if the clock frequency is less than 10MHz.</p> <p>For option 0x0 (fast window), see freq_fast_window. For option 0x1 (slow window), see freq_slow_window.</p> <p>0x0 = fast 0x1 = slow</p>

FREQMON_THRESH Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
47:24	freq_max_thresh	RW	0x0	Frequency Monitor Max Threshold. If the number of rising edges of the monitored clock at the end of a monitoring window exceeds this threshold, then the monitor's freq_sts and freqX_evt bits are set; freq_sts will remain set until the end of the next window where the counted number of rising edges is less than this threshold and greater than freq_min_thresh. Set to 0 to disable the frequency monitor.
23:0	freq_min_thresh	RW	0x0	Frequency Monitor Min Threshold. If the number of rising edges of the monitored clock at the end of a monitoring window is less than this threshold, then the monitor's freq_sts and freqX_evt bits are set; freq_sts will remain set until the end of the next window where the counted number of rising edges exceeds this threshold and is less than freq_max_thresh.

3.8 APLL

APLL control registers.

Table 10. APLL Register Index

Offset (Hex)	Register Module Base Address: 0xB0	
	Register Name	Register Description
0x0	APLL_FB_DIV_FRAC	APLL Feedback Divider Fraction Setting
0x4	APLL_FB_DIV_INT	APLL Feedback Divider Integer Setting
0x6	APLL_FB_SDM_CNFG	APLL Feedback Divider SDM Setting
0x7	APLL_CNFG	APLL Configuration
0x8	CP_CNFG	Charge Pump Configuration
0xA	LPF_CNFG	Filter Configuration
0xB	LPF_3RD_CNFG	Filter 3rd Pole Setting
0xC	APLL_XTAL_CNFG	APLL XTAL/Switching Configuration
0x10	VCO_DAC_CNFG	VCO DAC Configuration
0x16	APLL_LOCK_CNFG	APLL Lock Configuration
0x18	APLL_LOCK_THRSH	APLL Lock Thresholds
0x19	ANA_CLK_EN	Ref/XTAL Clock Enables
0x1C	BANK_MUX_CLK_EN	Output Mux Enables
0x20	VCO_CAL_CNFG	VCO Calibration Configuration
0x22	VCO_TRIM_CNFG	VCO Calibration Trim Configuration

3.8.1 APLL_FB_DIV_FRAC

APLL Feedback Divider Fraction Setting.

APLL_FB_DIV_FRAC Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:27	reserved	RO	0x0	Reserved
26:0	apll_fb_div_frac	RW	0x0	APLL Feedback Divider Fraction. APLL feedback divider numerator value. The denominator is a fixed value of 2^{27} .

3.8.2 APLL_FB_DIV_INT

APLL Feedback Divider Integer Setting.

APLL_FB_DIV_INT Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:10	reserved	RO	0x0	Reserved
9:0	apll_fb_div_int	RW	0x69	APLL Feedback Divider Integer. APLL feedback divider integer value.

3.8.3 APLL_FB_SDM_CNFG

APLL Feedback Divider SDM Setting.

APLL_FB_SDM_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:6	reserved	RO	0x0	Reserved
5	apll_fb_dither_en	RW	0x0	APLL Feedback SDM Dither Enable. Dither enable for the SDM controlling the APLL feedback divider. 0x0 = dither disabled 0x1 = dither enabled
4	apll_fb_dither_ns	RW	0x0	APLL Feedback SDM Dither Noise shaping. Dither noise shaping enable for the SDM controlling the APLL feedback divider. 0x0 = dither not shaped 0x1 = dither shaped
3:2	apll_fb_dither_gain	RW	0x0	APLL Feedback SDM Dither Gain. Gain control for the SDM controlling the APLL feedback divider. 0x0 = LSB 0x1 = 2*LSB 0x2 = 4*LSB 0x3 = 8*LSB
1:0	apll_fb_sdm_order	RW	0x3	APLL Feedback SDM Order. Selects the order of the SDM controlling the feedback divider for the APLL. 0x0 = Integer 0x1 = 1st order 0x2 = 2nd order 0x3 = 3rd order

3.8.4 APLL_CNFG

APLL Configuration.

APLL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:0	reserved	RW	0x3	Reserved

3.8.5 CP_CNFG

Charge Pump Configuration.

CP_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:14	reserved	RO	0x0	Reserved
13	cp_offset_en	RW	0x0	Charge Pump offset current enable. Writing this bit to a '1' enables the charge pump offset current. 0x0 = disabled 0x1 = enabled
12	cp_offset_boost	RW	0x0	Charge Pump offset current boost. Controls the charge pump offset range. This is the value applied before an XTAL switch or after ramping (if enabled) after an XTAL switch event. If the value programmed is 0, the value will remain at 0 before, during, and after an XTAL switch. 0x0 = 0uA to 145uA 0x1 = 0uA to 236uA
11:8	cnf_cp_offset	RW	0x3	Charge Pump offset current setting. This is the value applied before an XTAL switch or after ramping (if enabled) after an XTAL switch event. If the value programmed is 0x0, the value will remain at 0x0 before, during, and after an XTAL switch. 0x0 = 0uA 0x1 = 5uA 0x2 = 10uA 0x3 = 15uA 0x4 = 20uA 0x5 = 25uA 0x6 = 30uA 0x7 = 35uA 0x8 = 40uA 0x9 = 45uA
	cnf_cp_offset (continued)			0xA = 50uA 0xB = 55uA 0xC = 60uA 0xD = 65uA 0xE = 70uA 0xF = 75uA
7	reserved	RW	0x0	Reserved

CP_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
6:4	cnf_cp_up	RW	0x3	Charge Pump up current setting. These bits control the charge pump up current. 0x0 = 250uA 0x1 = 500uA 0x2 = 750uA 0x3 = 1mA 0x4 = 1.25mA 0x5 = 1.5mA 0x6 = 1.75mA 0x7 = 2mA
3	reserved	RW	0x0	Reserved
2:0	cnf_cp_dn	RW	0x3	Charge Pump down current setting. These bits control the charge pump down current. 0x0 = 250uA 0x1 = 500uA 0x2 = 750uA 0x3 = 1mA 0x4 = 1.25mA 0x5 = 1.5mA 0x6 = 1.75mA 0x7 = 2mA

3.8.6 LPF_CNFG

Filter Configuration.

LPF_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	apll_vco_filter_byp	RW	0x0	VCO current source filter bypass. Writing this bit to a '1' bypasses the APLL VCO filter. 0x0 = filter active 0x1 = filter bypassed
6:4	cnf_lpf_cp	RW	0x7	Loop filter pole capacitor setting. These bits control the Low Pass Filter pole capacitor. 0x0 = 11pF 0x1 = 14.7pF 0x2 = 18.4pF 0x3 = 22.1pF 0x4 = 25.8pF 0x5 = 29.5pF 0x6 = 33.2pF 0x7 = 36.9pF

LPF_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3:0	cnf_lpf_res	RW	0x4	Loop filter resistor setting. These bits control the Low Pass Filter resistor configuration. 0x0 = 0ohm 0x1 = 400ohm 0x2 = 800ohm 0x3 = 1.2kohm 0x4 = 1.6kohm 0x5 = 2kohm 0x6 = 2.4kohm 0x7 = 2.8kohm 0x8 = 3.2kohm 0x9 = 3.6kohm
	cnf_lpf_res (continued)			0xA = 4kohm 0xB = 4.4kohm 0xC = 4.8kohm 0xD = 5.2kohm 0xE = 5.6kohm 0xF = 6kohm

3.8.7 LPF_3RD_CNFG

Filter 3rd Pole Setting.

LPF_3RD_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	byp_p3	RW	0x0	Bypass 3rd pole. This bit may only be set to 1 when operating with an integer feedback divider. 0x0 = 3rd pole active 0x1 = 3rd pole bypassed
6:4	cnf_lpf_r3	RW	0x4	Loop filter 3rd pole resistor setting. These bits control the Low Pass Filter 3rd pole resistor configuration. 0x0 = 0ohm 0x1 = 800ohm 0x2 = 1.6kohm 0x3 = 2.4kohm 0x4 = 3.2kohm 0x5 = 4kohm 0x6 = 4.8kohm 0x7 = 5.6kohm

LPF_3RD_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3	reserved	RO	0x0	Reserved
2:0	cnf_lpf_c3	RW	0x4	<p>Loop filter 3rd pole capacitor setting. These bits control the Low Pass Filter 3rd pole capacitor configuration.</p> <p>0x0 = 0pF 0x1 = 1pF 0x2 = 2pF 0x3 = 3pF 0x4 = 4pF 0x5 = 5pF 0x6 = 6pF 0x7 = 7pF</p>

3.8.8 APLL_XTAL_CNFG

APLL XTAL/Switching Configuration.

APLL_XTAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:30	reserved	RO	0x0	Reserved
29:27	apll_xtalsw_cp_step_interval	RW	0x1	<p>Sets the apll_cnf_cp_offset ramp step interval. This is the interval between each apll_cnf_cp_offset increment and after which apll_cnf_cp_offset_boost is enabled again (if enabled in the cp_offset_boost register field). When cnf_cp_offset=0, the apll_cnf_cp_offset_boost is set back to its register field setting (cp_offset_boost) after 2 apll_xtalsw_cp_step_interval times. Each 1 means a interval of 1us, the interval can be 1us-7us</p> <p>0x1 = 1us 0x2 = 2us 0x3 = 3us 0x4 = 4us 0x5 = 5us 0x6 = 6us 0x7 = 7us</p>
26:24	apll_xtalsw_cp_step_size	RW	0x1	<p>Sets the apll_cnf_cp_offset ramp step size. When apll_xtal_sw_cp_step_en=1, the apll_cnf_cp_offset will be set back to its original value (cnf_cp_offset register field) through series of steps after an XTAL switch. The apll_cnf_cp_offset is incremented with apll_xtalsw_cp_step_size between each step interval. After apll_cnf_cp_offset reaches its original value, apll_cnf_cp_offset_boost is enabled again (if enabled in the cp_offset_boost register field). The step size is between 1-7.</p>
23	apll_xtalsw_cp_step_en	RW	0x1	<p>Enables the ramping of apll_cnf_cp_offset from 0 to its original value after xtal switch. When setting to 0, apll_cnf_cp_offset and apll_cnf_cp_offset_boost will not be changed, when setting to one, apll_cnf_cp_offset and apll_cnf_cp_offset_boost will change to 0, then step back to original value according to setting of apll_xtal_sw_cp_step_size and apll_xtal_sw_cp_step_interval</p> <p>0x0 = ramp disabled 0x1 = ramp enabled</p>

APLL_XTAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
22:19	apll_xtalsw_fb_rst_adj	RW	0xC	APLL Feedback Divider Adjust Value. This signed offset value gets applied to the first two cycles of the APLL feedback divider after the reset is issued by the XTAL switching circuit, if apll_xtalsw_fb_rst_adj_en is set to 1. Defaults to -4.
18	apll_xtalsw_fb_rst_adj_en	RW	0x0	APLL Feedback Divider Override during XTAL Switch. When set, enables the feedback divider override during the xtal switching procedure. The value is overridden to the current value from the SDM plus the value from the apll_xtalsw_fb_rst_adj field.
17:15	apll_xtalsw_wait_fb_sel	RW	0x3	feedback divider is reset. The feedback divider will be reset until the selected positive edge of the doubler. E.g. setting it to 3 means the feedback divider is reset until the 3rd positive edge of doubler. Minimum is three. Maximum is six. 0x3 = 3rd edge 0x4 = 4th edge 0x5 = 5th edge 0x6 = 6th edge
14:12	apll_xtalsw_wait_cp_sel	RW	0x4	Controls the time that charge pump is disabled. The charge pump will remain disabled until the selected positive edge of the doubler. E.g. setting it to 4 means the charge pump remains disabled until the 4th positive edge of doubler. Minimum is three. Maximum is six. 0x3 = 3rd edge 0x4 = 4th edge 0x5 = 5th edge 0x6 = 6th edge
11	apll_en_xtalsw_fb_reset	RW	0x1	Enable pin for feedback reset block. If enabled (1), when the xtal breaks, it will reset APLL feedback divider. 0x0 = disabled 0x1 = enabled
10	apll_en_xtalsw_cp	RW	0x1	Active High enable pin for charge pump enable block. If enabled (1), when the xtal breaks and it switches to the other crystal (apll_xtal_sw=1), it will disable the charge pump to minimize excursion. 0x0 = disabled 0x1 = enabled
9	apll_en_dn_pw_limiter	RW	0x1	Enable pin for down pulse width limiter block. If enabled (1), it will limit the pulse width of down signal to a value set by cnf_pw_dn<3:0>. When the chip starts up, en_dn_pw_limiter needs to be zero (0). Once it locks, it can be enabled (1). 0x0 = disabled 0x1 = enabled
8	apll_en_up_pw_limiter	RW	0x1	Enable pin for up pulse width limiter block. If enabled (1), it will limit the pulse width of up signal to a value set by cnf_pw_up<3:0>. When the chip starts up, en_up_pw_limiter needs to be zero (0). Once it locks, it can be enabled (1). 0x0 = disabled 0x1 = enabled

APLL_XTAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	apl_cnf_pw_dn	RW	0x8	4 bit tuning capacitor to control the down pulse width. Controls the maximum pulse width of PFD pulse width limiter for down signal. Default value is 5, which limits the pulse width of down signal to 1ns.
3:0	apl_cnf_pw_up	RW	0x8	4 bit tuning capacitor to control the up pulse width. Controls the maximum pulse width of PFD pulse width limiter for up signal. Default value is 5, which limits the pulse width of up signal to 1ns.

3.8.9 VCO_DAC_CNFG

VCO DAC Configuration.

VCO_DAC_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	reserved	RO	0x0	Reserved
3:0	cnf_vco_dac	RW	0x5	VCO control voltage DAC setting. Controls the VCO DAC voltage as shown in the decode. 0x0 = 0V 0x1 = 75mV 0x2 = 150mV 0x3 = 225mV 0x4 = 300mV 0x5 = 375mV 0x6 = 450mV 0x7 = 525mV 0x8 = 600mV 0x9 = 675mV
	cnf_vco_dac (continued)			0xA = 750mV 0xB = 825mV 0xC = 900mV 0xD = 975mV 0xE = 1.050V 0xF = 1.125V

3.8.10 APLL_LOCK_CNFG

APLL Lock Configuration.

APLL_LOCK_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:14	reserved	RO	0x0	Reserved
13	apl_lock_xtalsw_byp	RW	0x0	Bypass the APLL lock gating after XTAL switch bypass. Directly pass chosen APLL lock through after XTAL switch and do not wait for number of cycles selected in apl_lock_gate_xtalw. 0x0 = lock gate in use 0x1 = lock gate is bypassed

APLL_LOCK_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
12:11	apll_lock_gate_xtalsw	RW	0x2	APLL Lock gating after XTAL Switch. Gate any potential change in APLL lock for this many APLL reference clock cycles after an XTAL switch 0x0 = 1024 cycles 0x1 = 2048 cycles 0x2 = 4096 cycles 0x3 = 8192 cycles
10	use_raw_lock	RW	0x0	APLL Lock Status Select to Pin. When set, the raw lock is sent to a GPIO status pin configured to select the APLL lock status.
9	apll_precision_lock_en	RW	0x1	APLL Precision Lock Detector Enable. When set, enables the lock detector using the ranges controlled by apll_th_refl and apll_th_refh.
8	apll_lock_timer_byp	RW	0x0	APLL Lock Timer Bypass. When cleared, the APLL lock timer debounce is used. When set, the APLL lock timer is bypassed. Bypassing the APLL Lock timer results in 0us of debounce. Not recommended to be set to '1' if apll_lock_xtalsw_byp is not also = '1'. 0x0 = debounce enabled 0x1 = bypassed
7:6	apll_lock_timer	RW	0x2	APLL Lock Timer. Controls the digital debounce interval for the lock indication for the APLL. This duration is a function of the system clock cycles. 0x0 = 5 cycles 0x1 = 285 cycles 0x2 = 2850 cycles 0x3 = 28500 cycles
5	sel_1time_lock	RW	0x0	One time lock select. Controls whether lock detection will occur once or continuously. When set to 0x1, once the lock signal asserts it will remain asserted even if the APLL loses lock. 0x0 = real-time lock 0x1 = One time lock
4	lck_detect_cal_byp	RW	0x0	Lock detect during calibration enable. Selects when the lock detector is enabled. When cleared, the Lock detector is enabled after VCO calibration completes. When set, the lock detector is enabled during and after VCO calibration. 0x0 = after VCO calibration 0x1 = during and after VCO calibration
3	lck_byp	RW	0x0	Lock detector disable. When enabled (option 0x0), the lock detector is enabled according to lck_detect_cal_byp and sel_1time_lock. When disabled (option 0x1), the Lock detector is disabled and the lock signal is asserted. Writing this bit to a '1' bypasses the APLL lock detector circuit. 0x0 = enabled 0x1 = disabled
2:0	lck_detect_ref_sel	RW	0x0	Lock detector reference select. Controls phase difference between up/down for PLL lock signal.

3.8.11 APLL_LOCK_THRSH

APLL Lock Thresholds.

APLL_LOCK_THRSH Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	apll_th_refh	RW	0x6	APLL Precision Lock High Threshold. Controls the high threshold voltage of the precision lock detector. The threshold is approximately $750\text{mV} + 20\text{mV} * \text{apll_th_refh}$. The default is around 870mV.
3:0	apll_th_refl	RW	0xA	APLL Precision Lock Low Threshold. Controls the low threshold voltage of the precision lock detector. The threshold is approximately $50\text{mV} + 18\text{mV} * \text{apll_th_refl}$. The default is around 230mV.

3.8.12 ANA_CLK_EN

Ref/XTAL Clock Enables.

ANA_CLK_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	reserved	RO	0x0	Reserved
6	en_apll_ref_omux	RW	0x0	APLL Reference Clock to Output Mux Enable. Enables fanout of the selected crystal clock to the output clock mux. 0x0 = disabled 0x1 = enabled
5	en_xtal1_hdiv_dig	RW	0x1	Crystal 1 Divided Clock to Digital Enable. Enables fanout of the crystal 1 Hdiv output clock to the digital logic. 0x0 = disabled 0x1 = enabled
4	en_xtal0_hdiv_dig	RW	0x1	Crystal 0 Divided Clock to Digital Enable. Enables fanout of the crystal 0 Hdiv output clock to the digital logic. 0x0 = disabled 0x1 = enabled
3	en_xtal1_dig	RW	0x1	Crystal 1 Clock to Digital Enable. Enables fanout of the crystal 1 clock to the digital logic. 0x0 = disabled 0x1 = enabled
2	en_xtal0_dig	RW	0x1	Crystal 0 Clock to Digital Enable. Enables fanout of the crystal 0 clock to the digital logic. 0x0 = disabled 0x1 = enabled
1	en_xtal1_apll	RW	0x1	Crystal 1 Clock to APLL Enable. Enables fanout of the crystal 1 clock to the APLL. 0x0 = disabled 0x1 = enabled
0	en_xtal0_apll	RW	0x1	Crystal 0 Clock to APLL Enable. Enables fanout of the crystal 0 clock to the APLL. 0x0 = disabled 0x1 = enabled

3.8.13 BANK_MUX_CLK_EN

Output Mux Enables.

BANK_MUX_CLK_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:25	reserved	RO	0x0	Reserved
24	en_clk_hpfod2_bnk6	RW	0x1	HPFOD 2 to Bank 6 Output Mux Enable. Enables fanout of HPFOD 2 output clock to Bank 6 output mux. 0x0 = disabled 0x1 = enabled
23	en_clk_hpfod2_bnk5	RW	0x1	HPFOD 2 to Bank 5 Output Mux Enable. Enables fanout of HPFOD 2 output clock to Bank 5 output mux. 0x0 = disabled 0x1 = enabled
22	en_clk_hpfod2_bnk4	RW	0x1	HPFOD 2 to Bank 4 Output Mux Enable. Enables fanout of HPFOD 2 output clock to Bank 4 output mux. 0x0 = disabled 0x1 = enabled
21	en_clk_hpfod2_bnk3	RW	0x1	HPFOD 2 to Bank 3 Output Mux Enable. Enables fanout of HPFOD 2 output clock to Bank 3 output mux. 0x0 = disabled 0x1 = enabled
20	en_clk_hpfod1_bnk6	RW	0x1	HPFOD 1 to Bank 6 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 6 output mux. 0x0 = disabled 0x1 = enabled
19	en_clk_hpfod1_bnk5	RW	0x1	HPFOD 1 to Bank 5 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 5 output mux. 0x0 = disabled 0x1 = enabled
18	en_clk_hpfod1_bnk4	RW	0x1	HPFOD 1 to Bank 4 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 4 output mux. 0x0 = disabled 0x1 = enabled
17	en_clk_hpfod1_bnk3	RW	0x1	HPFOD 1 to Bank 3 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 3 output mux. 0x0 = disabled 0x1 = enabled
16	en_clk_hpfod1_bnk2	RW	0x1	HPFOD 1 to Bank 2 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 2 output mux. 0x0 = disabled 0x1 = enabled
15	en_clk_hpfod1_bnk1	RW	0x1	HPFOD 1 to Bank 1 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 1 output mux. 0x0 = disabled 0x1 = enabled

BANK_MUX_CLK_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
14	en_clk_hpfod1_bnk0	RW	0x1	HPFOD 1 to Bank 0 Output Mux Enable. Enables fanout of HPFOD 1 output clock to Bank 0 output mux. 0x0 = disabled 0x1 = enabled
13	en_clk_hpfod0_bnk3	RW	0x1	HPFOD 0 to Bank 3 Output Mux Enable. Enables fanout of HPFOD 0 output clock to Bank 3 output mux. 0x0 = disabled 0x1 = enabled
12	en_clk_hpfod0_bnk2	RW	0x1	HPFOD 0 to Bank 2 Output Mux Enable. Enables fanout of HPFOD 0 output clock to Bank 2 output mux. 0x0 = disabled 0x1 = enabled
11	en_clk_hpfod0_bnk1	RW	0x1	HPFOD 0 to Bank 1 Output Mux Enable. Enables fanout of HPFOD 0 output clock to Bank 1 output mux. 0x0 = disabled 0x1 = enabled
10	en_clk_hpfod0_bnk0	RW	0x1	HPFOD 0 to Bank 0 Output Mux Enable. Enables fanout of HPFOD 0 output clock to Bank 0 output mux. 0x0 = disabled 0x1 = enabled
9	en_clk_iod1_bnk6	RW	0x1	IOD 1 to Bank 6 Output Mux Enable. Enables fanout of IOD 1 output clock to Bank 6 output mux. 0x0 = disabled 0x1 = enabled
8	en_clk_iod1_bnk5	RW	0x1	IOD 1 to Bank 5 Output Mux Enable. Enables fanout of IOD 1 output clock to Bank 5 output mux. 0x0 = disabled 0x1 = enabled
7	en_clk_iod1_bnk4	RW	0x1	IOD 1 to Bank 4 Output Mux Enable. Enables fanout of IOD 1 output clock to Bank 4 output mux. 0x0 = disabled 0x1 = enabled
6	en_clk_iod0_bnk6	RW	0x1	IOD 0 to Bank 6 Output Mux Enable. Enables fanout of IOD 0 output clock to Bank 6 output mux. 0x0 = disabled 0x1 = enabled
5	en_clk_iod0_bnk5	RW	0x1	IOD 0 to Bank 5 Output Mux Enable. Enables fanout of IOD 0 output clock to Bank 5 output mux. 0x0 = disabled 0x1 = enabled
4	en_clk_lpfod1_bnk2	RW	0x1	LPFOD 1 to Bank 2 Output Mux Enable. Enables fanout of LPFOD 1 output clock to Bank 2 output mux. 0x0 = disabled 0x1 = enabled

BANK_MUX_CLK_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3	en_clk_lpfod1_bnk1	RW	0x1	LPFOD 1 to Bank 1 Output Mux Enable. Enables fanout of LPFOD 1 output clock to Bank 1 output mux. 0x0 = disabled 0x1 = enabled
2	en_clk_lpfod1_bnk0	RW	0x1	LPFOD 1 to Bank 0 Output Mux Enable. Enables fanout of LPFOD 1 output clock to Bank 0 output mux. 0x0 = disabled 0x1 = enabled
1	en_clk_lpfod0_bnk1	RW	0x1	LPFOD 0 to Bank 1 Output Mux Enable. Enables fanout of LPFOD 0 output clock to Bank 1 output mux. 0x0 = disabled 0x1 = enabled
0	en_clk_lpfod0_bnk0	RW	0x1	LPFOD 0 to Bank 0 Output Mux Enable. Enables fanout of LPFOD 0 output clock to Bank 0 output mux. 0x0 = disabled 0x1 = enabled

3.8.14 VCO_CAL_CNFG

VCO Calibration Configuration.

VCO_CAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15	vco_cal_div_en	RW	0x1	VCO Calibration Manual Divider Enable. When set, forces the VCO calibration divider to be enabled. This must be enabled to support the LOS monitor and XTAL switching logic. 0x0 = disabled 0x1 = enabled
14:13	vco_settle_count	RW	0x3	VCO Calibration settle count value. Selects the number of reference clock cycles for allowing the VCO to settle before doing the frequency measurement, as described in VCO Calibration). This field cannot be set to the same count value as the vco_cal_count field. 0x0 = 64 cycles 0x1 = 128 cycles 0x2 = 256 cycles 0x3 = 512 cycles
12	vco_trim_cal_en	RW	0x1	VCO Trim Calibration enable. Enables calibration of the trim bits in addition to the normal frequency band selection. When the bit is set, the trim bits are controlled by the calibration logic and not the vco_trim field. 0x0 = disable trim calibration 0x1 = enable trim calibration
11	vco_cal_div	RW	0x1	VCO Calibration divider value. Selects the clock divider value used for calibration (the VCOFixedDiv value described in VCO Calibration). 0x0 = divide by 32 0x1 = divide by 16

VCO_CAL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
10:8	vco_cal_count	RW	0x2	VCO Calibration timer value. Indicates the duration of each band calibration measurement (the REFCOUNT value described in VCO Calibration). For reference frequencies less than 30MHz, this field should be set to 0x5 (512 cycles). For frequencies less than 50MHz, it should be set to 0x0 (1024 cycles). For frequencies less than 120MHz, it should be set to 0x1 (2048 cycles). For frequencies less than 240MHz, it should be set to 0x2 (4096). For higher frequencies, it should be set to 0x3 (8192). This field cannot be set to the same count value as the vco_settle_count field. 0x0 = 1024 cycles 0x1 = 2048 cycles 0x2 = 4096 cycles 0x3 = 8192 cycles 0x4 = 256 cycles 0x5 = 512 cycles
7	reserved	RO	0x0	Reserved
6	vco_cal_byp	RW	0x0	VCO Calibration bypass. Disables automatic VCO calibration during startup. When VCO calibration is enabled, the band selected by the VCO calibration logic (vco_cap) is applied to the VCO. When VCO calibration is disabled, the band programmed in vco_sw_cap is applied to the VCO. 0x0 = enabled 0x1 = disabled
5:0	vco_sw_cap	RW	0x20	VCO Calibration bypass frequency band select. Provides the band to apply to the VCO when calibration is bypassed by setting vco_cal_byp to 1.

3.8.15 VCO_TRIM_CNFG

VCO Calibration Trim Configuration.

VCO_TRIM_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	reserved	RO	0x0	Reserved
6:4	vco_cal_startup_count	RW	0x2	VCO Startup Count. Controls the delay period between asserting the signal indicating start of calibration and the actual start of the calibration search. This delay is to allow the charging of the control voltage capacitor. This period is in reference clock cycles (without doubler). 0x0 = 1200 cycles 0x1 = 2500 cycles 0x2 = 4000 cycles 0x3 = 6400 cycles 0x4 = 15625 cycles 0x5 = 28195 cycles 0x6 = 34375 cycles
3	reserved	RO	0x0	Reserved

VCO_TRIM_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
2	vco_trim_wr_en	RW	0x1	VCO Trim Write Enable. Enables writing to the vco_trim field. This bit is programmed to 0 at the factory in the OTP common configuration. If the user must write to this register during the configuration load or during a serial port burst write, the value written should be 0x0. 0x0 = VCO_trim is read-only 0x1 = VCO_trim is write-able
1:0	vco_trim	RW	0x1	Coarse VCO Tuning. Shifts the VCO range to set the center frequency closest to 10.5 GHz. It may only be written when vco_trim_wr_en is set to 1. This value is programmed at the factory in the OTP common configuration. When vco_trim_cal_en is set to 1, the VCO calibration logic controls the trim value and this field is unused.

3.9 SSC

Spread spectrum registers.

Table 11. SSC Register Index

Offset (Hex)	Register Module Base Address: 0xF0	
	Register Name	Register Description
0x0	SSC_CNFG	Spread Spectrum Configuration

3.9.1 SSC_CNFG

Spread Spectrum Configuration.

SSC_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31	ssc_en	RW	0x0	Spectrum Spreading Enable. Enable spread spectrum. The spread configuration is determined by the other register fields in this register. If the FOD0 and FOD1 SSC modulation frequencies are the same, the FOD1 SSC phase may be aligned to FOD0 SSC by setting ssc_sync to 1. Note: When ssc_sync is set to 1, then FOD1 ssc_en must be set to 1 before FOD0 ssc_en is set to 1 since FOD1 SSC will start when FOD0 ssc_en is set to 1. This restriction does not apply when loading the device configuration from OTP on startup, but does apply if dynamically changing these settings later by writing registers from the serial interface. 0x0 = SSC disabled 0x1 = SSC enabled
30	ssc_mode	RW	0x0	Spectrum Spreading Mode. Selects the spread direction. 0x0 = down spreading 0x1 = center spreading
29:24	reserved	RO	0x0	Reserved

SSC_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
23:16	ssc_ampl	RW	0x51	<p>Spectrum Spreading Amplitude. Sets the positive and negative spreading amplitude. For down spread, ssc_ampl is only used for the negative limit and the positive limit is internally set to 0. For center spread, the peak-to-peak spread amplitude is twice the specified amplitude (for a 1% peak-to-peak center spread, define ssc_ampl as 0.5%).</p> $\text{ssc_ampl} = \text{spread_percentage} / 100 * 2^{14}$ <p>for example, for 1% spread, set ssc_ampl to $0.01 * 2^{14} = 163$ decimal, or 0xA3</p> <p>The default value corresponds to a 0.5% down spread at 31.5kHz.</p>
15:0	ssc_step	RW	0x2B8 C	<p>Spectrum Spreading Step Size. Set ramp step size to get the target modulation rate. For down spread:</p> $\text{ssc_step} = \text{ssc_ampl} * 2^{16} * \text{ssc_freq} / 15\text{MHz}$ <p>For center spread:</p> $\text{ssc_step} = 2 * \text{ssc_ampl} * 2^{16} * \text{ssc_freq} / 15\text{MHz}$ <p>where,</p> <p>ssc_freq is the target modulation rate from 30kHz to 63kHz 15MHz is the system clock divided by 8, assuming the system clock is 60MHz</p> <p>Example 1. For a 32kHz 1% down spread: $\text{ssc_ampl} = 163$ $\text{ssc_step} = 163 * 2^{16} * 32\text{kHz} / 15\text{MHz} = 0x5905$</p> <p>Example 2. For a 32kHz +/- 0.5% center spread: $\text{ssc_ampl} = 81$ $\text{ssc_step} = 2 * 81 * 2^{16} * 32\text{kHz} / 15\text{MHz} = 0x5879$</p> <p>The default value corresponds to a 0.5% down spread at 31.5kHz.</p>

3.10 IOD

Integer Output Divider registers.

Table 12. IOD Register Index

Offset (Hex)	Register Module Base Address: 0x100	
	Register Name	Register Description
0x0	IOD_INT_CNFG	IOD Divider/Configuration
0x4	IOD_PHASE_CNFG	IOD Phase Configuration

3.10.1 IOD_INT_CNFG

IOD Divider/Configuration.

IOD_INT_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31	iod_pd	RW	0x0	Integer Output Divider Power Down. Powers down the integer output divider by turning off the regulator. If this bit is set to 1, iod_rst must also be set to 1. When clearing this bit, iod_rst must remain set and then it may be cleared afterwards. 0x0 = divider is powered up 0x1 = divider is powered down
30	iod_dis	RW	0x0	Integer Output Divider Disable. Disables the integer output divider. If this bit is set to 1, iod_rst must also be set to 1. When clearing this bit, iod_rst must remain set and then it may be cleared afterwards. 0x0 = divider enabled 0x1 = divider disabled
29	iod_rst	RW	0x0	Integer Output Divider Reset. Resets the integer output divider. 0x0 = divider reset deasserted 0x1 = divider reset asserted
28:25	reserved	RO	0x0	Reserved
24:0	iod_int	RW	0x64	Integer Output Divider Ratio. Integer output divider ratio. The minimum value is 14. This register is atomic. When the most significant byte (bit [24]) is written, the new value is applied to the IOD. If the old or new iod_int value is less than 32 and the part is being programmed via serial bus (not OTP), please set iod_rst to '1', write the new iod_int value, and then set iod_rst to '0'.

3.10.2 IOD_PHASE_CNFG

IOD Phase Configuration.

IOD_PHASE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15	iod_ph_adj_now	RW1S	0x0	Integer Output Divider Phase Adjustment Now. When this bit is written from 0 to 1, the phase adjustment in iod_phase is applied to the divider. This bit self-clears when the adjust completes. This bit should not be set to 1 if iod_pd = 1 or iod_rst = 1.
14	iod_ph_adj_post_sync	RW	0x0	Integer Output Divider Phase Adjustment After Synchronization. When this bit is set to 1, the phase adjustment in iod_phase is applied to the divider whenever the divider is synchronized. This bit should not be set to 1 if iod_pd = 1 or iod_rst = 1.
13:9	reserved	RO	0x0	Reserved
8:0	iod_phase	RW	0x0	Integer Output Divider Phase Configuration. Signed 2's complementary value sets the phase, a positive value means lag from 0 phase, a negative value means lead from 0 phase, in steps of one VCO period. When negative, (iod_int/2 - iod_phase) must be >= 6. The available range is +/- 0~255 steps (approximately +/- 0~20ns). This register is atomic. When the most significant byte (bit [8]) is written, the new value is applied to the IOD according to iod_ph_adj_now and iod_ph_adj_post_sync.

3.11 HPFOD

High Performance Fractional Output Divider registers.

Table 13. HPFOD Register Index

Offset (Hex)	Register Module Base Address: 0x110	
	Register Name	Register Description
0x0	HPFOD_INT_CNFG	HPFOD Divider/Configuration
0x8	HPFOD_PHASE_CNFG	HPFOD Phase Configuration

3.11.1 HPFOD_INT_CNFG

HPFOD Divider/Configuration.

HPFOD_INT_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
63	hpfod_pd	RW	0x0	High Performance Fractional Output Divider Power Down. Powers down the HP fractional output divider by turning off the regulator. If this bit is set to 1, hpfod_rst must also be set to 1. When clearing this bit, hpfod_rst must remain set and then it may be cleared afterwards. 0x0 = divider is powered up 0x1 = divider is powered down
62	hpfod_dis	RW	0x0	High Performance Fractional Output Divider Disable. Disables the HP fractional output divider. If this bit is set to 1, hpfod_rst must also be set to 1. When clearing this bit, hpfod_rst must remain set and then it may be cleared afterwards. 0x0 = divider enabled 0x1 = divider disabled
61	hpfod_rst	RW	0x0	High Performance Fractional Output Divider Reset. Resets the HP fractional output divider. 0x0 = divider reset deasserted 0x1 = divider reset asserted
60	hpfod_acc_reset	RW	0x0	HPFOD SDM accumulator reset. Writing this bit to a '1' resets the HPFOD SDM accumulator. 0x0 = accumulator reset deasserted 0x1 = accumulator reset asserted
59:26	hpfod_frac	RW	0x0	High Performance Fractional Output Divider Ratio Fraction portion. Denominator is fixed to 2^{34} . This register field is part of an atomic group consisting of hpfod_1st_int and hpfod_frac. When the most significant byte (bits [33:30]) of hpfod_frac is written, the value of all these fields are applied to the HPFOD. Note: When an HPFOD has spread-spectrum, hpfod_frac[5:0] must be set to 0x0.
25:9	hpfod_2nd_int	RW	0x0	High Performance Fractional Output Divider Ratio High Performance 2nd Integer portion. Half integer divide ratio of second stage. The actual divide ratio is (hpfod_2nd_int * 2). A setting of 1 is invalid: the minimum divide ratio is 4. Set to 0 to bypass the second stage.

HPFOD_INT_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
8:0	hpfod_1st_int	RW	0x64	High Performance Fractional Output Divider Ratio 1st Integer portion. Integer divide ratio of first stage (MMD). This register field is part of an atomic group consisting of hpfod_1st_int and hpfod_frac. When the most significant byte (bits [8:7]) of hpfod_1st_int or the most significant byte (bits [33:30]) of hpfod_frac is written, the value of all these fields are applied to the HP FOD. The allowed frequency range for after this first divider stage (hpfod_1st_int plus hpfod_frac) is 33MHz-650MHz. Only set divider values within this range. Note: Refer to hpfod_frac for details regarding serial bus writes to this register field.

3.11.2 HPFOD_PHASE_CNFG

HPFOD Phase Configuration.

HPFOD_PHASE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15	hpfod_ph_adj_now	RW1S	0x0	High Performance Fractional Output Divider Phase High Performance Adjustment Now. When this bit is written from 0 to 1, the phase adjustment in hpfod_phase is applied to the divider. This bit self-clears when the adjust completes.
14	hpfod_ph_adj_post_sync	RW	0x1	High Performance Fractional Output Divider Phase Adjustment After Synchronization. When this bit is set to 1, the phase adjustment in hpfod_phase is applied to the divider whenever the divider is synchronized.
13	hpfod_slow_freq_en	RW	0x0	High Performance FOD Slow Frequency enable. Must be set to 1 when the MMD (first stage) frequency is under 70 MHz.
12:10	reserved	RO	0x0	Reserved
9:0	hpfod_phase	RW	0x3F0	High Performance Fractional Output Divider Phase Configuration. signed 2's complementary value sets the phase, a positive value means lag from 0 phase, a negative value means lead from 0 phase, in steps of 1/4 VCO period. The default value of -16 (decimal), or -4.0 VCO periods, approximately aligns the HP FOD output clock with the IOD output clock, when the HP FOD is configured with an integer divide ratio. This correction factor needs to be adjusted for fractional divide ratios. This register is atomic. When the most significant byte (bits [9:8]) is written, the new value is applied to the FOD according to hpfod_ph_adj_now and hpfod_ph_adj_post_sync.

3.12 DCD

DCD control registers for HPFOD's.

Table 14. DCD Register Index

Offset (Hex)	Register Module Base Address: 0x140	
	Register Name	Register Description
0x0	DCD_CNFG	DCD Configuration
0x4	DCD_MAN_CNFG	DCD Manual Control
0x6	DCD_ACCEL_CNFG	DCD Accelerated Calibration Settings
0x8	DCD_CTRL	DCD Status Selection

3.12.1 DCD_CNFG

DCD Configuration.

DCD_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:27	dcd_slow_gain_shift	RW	0x10	DCD Calibration Slow Filter Gain Shift. Controls the gain shift in the DCD calibration slow filter mode. The suggested range is 15 to 17.
26	reserved	RO	0x0	Reserved
25	fod_spare	RW	0x0	FOD/DCD Spare Configuration Bits. Unused.
24	dcd_slow_en	RW	0x0	DCD Calibration Slow Filter Mode enable. Enables the DCD calibration slow filter mode, after dcd_slow_start_delay following the end of accelerated calibration. The gain shift is set by dcd_slow_gain_shift. The update rate (common to all FODs) is set by dcd_slow_update_rate. This bit must be set to 0 if either dcd_integer_mode or dcd_holdover_mode are set to 1.
23:22	dcd_fast_lock_lpf_sel	RW	0x0	DCD Fast Lock Low Pass Filter Coefficient selection. Selects the DCD calibration LPF coefficient used when dcd_fast_lock is set to 1. 0x0 = coefficient is 0x0B 0x1 = coefficient is 0x0C 0x2 = coefficient is 0x0D 0x3 = coefficient is 0x0E
21	dcd_fast_lock	RW	0x0	DCD Fast Lock Mode. Enables faster calibration, but with higher phase noise. This bit may be set to 1 to enable a quick initial calibration, and then should be set to 0 for normal operation. dcd_fast_lock_lpf_sel selects the LPF coefficient used during fast lock, instead of the normal dcd_calib_lpf. Fast lock is automatically enabled during accelerated calibration for the time interval specified by dcd_accel_fast_lock; this bit should be set to 0 unless performing a manual fast lock. This will be automatically controlled on startup to calibrate the DCD before the output clocks are enabled.
20:16	dcd_calib_deci	RW	0xA	DCD Calibration Decimator Filter coefficient. The DCD calibration decimator coefficient used. Maximum value is 0xA = 'd10.
15	robust_gro_state_en	RW	0x1	Robust GRO State Decode enable. Set to 1 to enable detection of transient GRO states. 0x0 = Robust GRO state off 0x1 = Robust GRO state on
14:13	phase_wrap_ctrl	RW	0x0	GRO Phase Wrapping Algorithm. Selects the GRO phase wrapping algorithm. This is for debugging purposes only and should generally not be modified. When set to 0, assumes that the GRO phase has wrapped around if the absolute value of the delta of the two GRO cycles is less if 34 is added to the delta or subtracted from the delta. 0x0 = Assumes wrap when delta is less when adding or subtracting 34 0x1 = Assumes wrap when delta is greater than 17 0x2 = Assumes wrap when delta is greater than 12
12:8	dcd_calib_lpf	RW	0x18	DCD Calibration Low Pass Filter coefficient. The DCD calibration LPF coefficient used when dcd_fast_lock is set to 0. Maximum value is 0x18 = 'd24.

DCD_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:6	dac_clk_ctrl	RW	0x1	DCD DAC SDM Clock Select. Selects the divisor when generating the DAC SDM clock. 0x0 = divide by 4 0x1 = divide by 8 0x2 = divide by 16 0x3 = divide by 16
5	dcd_holdover_mode	RW	0x0	DCD Calibration Holdover Mode. Enables DCD FOD calibration holdover. 0x0 = normal operation 0x1 = DCD calibration in holdover mode
4	dcd_integer_mode	RW	0x0	DCD FOD Integer Mode. When '1' force DAC output from calibration block to all '0's. If this bit is set before or during accelerated calibration, integer mode is enabled internally after accelerated calibration ends. If this bit is set to 1, then dcd_slow_en must be set to 0. It will be forced to 0 internally while SSC is active (FOD 0 and 1 only). 0x0 = normal 0x1 = use FOD in integer mode
3:2	dcd_dac_sdm_order	RW	0x2	DCD DAC SDM Order. Selects DAC SDM order. 0x0 = sdm off 0x1 = 1st order 0x2 = 2nd order 0x3 = Round to closest value, sdm off
1	dcd_bw_sel	RW	0x0	DCD analog filter for DAC selection. Selects between 50kHz analog filter bandwidth and 200kHz analog filter bandwidth. When 0x0, selects 50KHz bandwidth for lower FOD frequencies. When 0x1, selects 200KHz bandwidth for higher FOD frequencies. 0x0 = 50KHz bw 0x1 = 200KHz bw
0	clr_gro_st_cnt	RW	0x0	DCD Calibration GRO Clear. Write '1' to clear the invalid GRO state counter. This bit must be written to 0 before it may be triggered again by writing it to 1.

3.12.2 DCD_MAN_CNFG

DCD Manual Control.

DCD_MAN_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15	dcd_calib_man	RW	0x0	DCD Manual Mode. Selects the DCD calibration mode. When set to manual (option 0x1), manual DCD gain will be used (dcd_manual_gain) 0x0 = auto 0x1 = manual
14:0	dcd_manual_gain	RW	0x6F00	DCD Manual Gain. In manual mode (when dcd_calib_man is set to 1), this field sets the DCD gain. This is a 15-bit signed 2's complement number. Note: The value obtained from reading i_err_sts may be written directly to dcd_manual_gain without any shifting.

3.12.3 DCD_ACCEL_CNFG

DCD Accelerated Calibration Settings.

DCD_ACCEL_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:9	reserved	RO	0x0	Reserved
8	dcd_accel_int	RW	0x1	<p>DCD Accelerated Calibration Integer select. Selects the HPFOD divider integer to use during the dcd_accel_fast_lock and dcd_accel_settle intervals. If a fixed integer is selected, a divider synchronization is automatically performed after the fraction reverts to hpfdod_int; as with the initial divider synchronization, this occurs before the clock outputs are enabled.</p> <p>When set to 0x0, use the integer programmed in hpfdod_int. When set to 0x1, use integer 100.</p> <p>0x0 = hpfdod_int 0x1 = 100</p>
7:6	dcd_accel_frac	RW	0x1	<p>DCD Accelerated Calibration Fraction select. Selects the HPFOD divider fraction to use during the dcd_accel_fast_lock and dcd_accel_settle intervals. If a fixed fraction is selected, a divider synchronization is automatically performed after the fraction reverts to hpfdod_frac; as with the initial divider synchronization, this occurs before the clock outputs are enabled.</p> <p>When set to 0x0, use the fraction programmed in hpfdod_frac. Otherwise use the selected fraction.</p> <p>0x0 = hpfdod_frac 0x1 = 0.25 0x2 = 0.5</p>
5:3	dcd_accel_fast_lock	RW	0x1	<p>DCD Accelerated Calibration Fast Lock Time Interval. The amount of time to run the DCD calibration with dcd_fast_lock set to 1 after the FOD comes out of reset (automatically during the startup sequence if fod_rst is 0 (on power-up or due to apll_reinit), or after startup when the fod_rst bit transitions from 1 to 0). If the dcd_accel_frac field is non-zero, the fraction is forced to a fixed value during this time.</p> <p>0x0 = 0ms (disabled) 0x1 = 0.5ms 0x2 = 1.0ms 0x3 = 2ms 0x4 = 4ms 0x7 = 16us</p>
2:0	dcd_accel_settle	RW	0x0	<p>DCD Accelerated Calibration Settling Time Interval. The amount of time to run the DCD calibration with dcd_fast_lock set to 0 after the dcd_accel_fast_lock interval ends, and before enabling clock outputs. If the dcd_accel_frac field is non-zero, the fraction is forced to a fixed value during this time.</p> <p>0x0 = 0ms (disabled) 0x1 = 0.5ms 0x2 = 1.0ms 0x3 = 2ms 0x4 = 4ms 0x7 = 16us</p>

3.12.4 DCD_CTRL

DCD Status Selection.

DCD_CTRL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:2	reserved	RO	0x0	Reserved
1:0	dcd_status_sel	RW	0x0	DCD Calibration Status Select. Selects the status to read back through gro_st_cnt and i_err_sts. Refer to those fields for details.

3.13 LPFOD

Limited Performance Fractional Output Divider Registers.

Table 15. LPFOD Register Index

Offset (Hex)	Register Module Base Address: 0x170	
	Register Name	Register Description
0x0	LPFOD_INT_CNFG	LPFOD Divider/Configuration
0x8	LPFOD_PHASE_CNFG	LPFOD Phase Configuration
0xA	LPFOD_MIN_DIV_PH_FRAC	LPFOD Minimum Divider for Phase and Fractional Support

3.13.1 LPFOD_INT_CNFG

LPFOD Divider/Configuration.

LPFOD_INT_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
63	lpfod_pd	RW	0x0	Limited Performance Fractional Output Divider Power Down. Powers down the LP fractional output divider by turning off the regulator. If this bit is set to 1, lpfod_rst must also be set to 1. When clearing this bit, lpfod_rst must remain set and then it may be cleared afterwards. 0x0 = powered up 0x1 = powered down
62	lpfod_dis	RW	0x0	Limited Performance Fractional Output Divider Disable. Disables the LP fractional output divider. If this bit is set to 1, lpfod_rst must also be set to 1. When clearing this bit, lpfod_rst must remain set and then it may be cleared afterwards. 0x0 = enabled 0x1 = disabled
61	lpfod_rst	RW	0x0	Limited Performance Fractional Output Divider Reset. Resets the LP fractional output divider. 0x0 = reset deasserted 0x1 = reset asserted
60	lpfod_sdm_order	RW	0x0	Limited Performance Fractional Output Divider SDM Order. Selects the order of the SDM controlling the LP FOD MMD. First order must be selected if lpfod_frac is non-zero. If the lpfod_int divider is less than the value in lpfod_min_div_ph_frac_supp, then fractional division is not supported and the order must be set to integer mode. 0x0 = Integer (no modulation) 0x1 = 1st order

LPFOD_INT_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
59:26	lpfod_frac	RW	0x0	Limited Performance Fractional Output Divider Ratio Fraction portion. Denominator is fixed to 2^{34} . If the lpfod_int value is less than the value in lpfod_min_div_ph_frac_supp, the LPFOD does not support fractional dividers and this field will be ignored and overridden to 0. If applying a new lpfod_frac value through a serial bus write (not through OTP), please set lpfod_rst to '1', write the new value into the lpfod_frac field, and then set lpfod_rst to '0' to latch the new value. This register field is part of an atomic group consisting of lpfod_int and lpfod_frac. When the most significant byte (bits [33:30]) of lpfod_frac is written, the value of all these fields are applied to the LPFOD.
25	reserved	RO	0x0	Reserved
24:0	lpfod_int	RW	0x64	Limited Performance Fractional Output Divider Ratio Integer portion. Integer divide ratio. If the lpfod_int value is less than the value in lpfod_min_div_ph_frac_supp, fractional dividers and phase adjustments cannot be used and the field lpfod_ph_adj_post_sync should always be set to 0. This field should only be programmed when lpfod_rst is high. If applying a new lpfod_int value through a serial bus write (not through OTP), please set lpfod_rst to '1', write the new value into the lpfod_int field, and then set lpfod_rst to '0' to latch the new value. This register field is part of an atomic group consisting of lpfod_int and lpfod_frac. When the most significant byte (bits [33:30]) of lpfod_frac is written, the value of all these fields are applied to the LPFOD. Note: Refer to lpfod_frac for details regarding serial bus writes to this register field.

3.13.2 LPFOD_PHASE_CNFG

LPFOD Phase Configuration.

LPFOD_PHASE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15	lpfod_ph_adj_now	RW1S	0x0	Limited Performance Fractional Output Divider Phase Adjustment Now. When this bit is written from 0 to 1, the phase adjustment in lpfod_phase is applied to the divider. This bit self-clears when the adjust completes. If the lpfod_int value is less than the value in lpfod_min_div_ph_frac_supp, this bit should never be set. This bit should not be set if lpfod_pd = 1 or lpfod_rst = 1.
14	lpfod_ph_adj_post_sync	RW	0x0	Limited Performance Fractional Output Divider Phase Adjustment After Synchronization. When this bit is set to 1, the phase adjustment in lpfod_phase is applied to the divider whenever the divider is synchronized. If the lpfod_int value is less than the value in lpfod_min_div_ph_frac_supp, this bit should never be set. This bit should not be set if lpfod_pd = 1 or lpfod_rst = 1.
13:9	reserved	RO	0x0	Reserved

LPFOD_PHASE_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
8:0	lpfod_phase	RW	0x0	Limited Performance Fractional Output Divider Phase Configuration. Signed 2's complementary value sets the phase, a positive value means lag from 0 phase, a negative value means lead from 0 phase, in steps of 1 VCO period. The default value of 0 (decimal), or 0 VCO periods, approximately aligns the LP FOD output clock with the IOD output clock, when the LP FOD is configured with an integer divide ratio. If the lpfod_int value is less than the value in lpfod_min_div_ph_frac_supp, phase adjustments are not supported and this field should not be programmed. This register is atomic. When the most significant byte (bits [10:8]) is written, the new value is applied to the LPFOD according to lpfod_ph_adj_now and lpfod_ph_adj_post_sync.

3.13.3 LPFOD_MIN_DIV_PH_FRAC

LPFOD Minimum Divider for Phase and Fractional Support.

LPFOD_MIN_DIV_PH_FRAC Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:6	reserved	RO	0x0	Reserved
5:0	lpfod_min_div_ph_frac_supp	RW	0x31	Minimum allowed integer divide value for LPFOD phase adjust and fractional divider support. This value is used to control the minimum allowed integer divider value for which the LPFOD supports having the SDM turned on. If the programmed integer divider value is less than this value, the SDM is disabled, the LPFOD will divide only by the integer portion (ignore the fractional part), and phase adjustments are not allowed. This field is not meant to be modified, it is for debugging only.

3.14 OUT

Output control registers.

Table 16. OUT Register Index

Offset (Hex)	Register Module Base Address: 0x190	
	Register Name	Register Description
0x0	ODRV_EN	Output Driver Settings
0x2	ODRV_CNFG	Output Driver Configuration

3.14.1 ODRV_EN

Output Driver Settings.

ODRV_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	out_pd	RW	0x0	Output Driver Power Down. Powers down the output clock driver. 0x0 = output driver is powered up 0x1 = output driver is powered down
6	out_oe_mode	RW	0x0	Output Driver OE Mode. Controls whether the output enable acts synchronously or asynchronously with respect to the output divider clock. When OE is synchronized to the divider clock (option 0x0), enabling and disabling the output clock is glitchless. OE transitions take effect after 1 divider clock cycle. When OE is asynchronous to the divider clock (option 0x1), OE transitions while the divider clock is toggling may result in glitches/runt pulses. 0x0 = OE synchronized 0x1 = OE asynchronous
5:3	out_dis_group	RW	0x0	Output Driver OE Group. Sets which OE group this driver is in. 0x0 = group0 0x1 = group1 0x2 = group2 0x3 = group3 0x4 = group4 0x5 = none
2:1	out_dis_state	RW	0x3	OUT Driver disabled state. Controls the state of OUTx / OUTxb when the output driver is disabled. In LVDS mode options 0x0 and 0x03 result in a different state: * 0x0: Held Low/High * 0x3: Held High/Low 0x0 = High/Low (Low/High for LVDS) 0x1 = Low/High 0x2 = Hi-Z/Hi-Z 0x3 = Low/Low (High/Low for LVDS)
0	reserved	RO	0x0	Reserved

3.14.2 ODRV_CNFG

Output Driver Configuration.

ODRV_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15	out_prog7	RW	0x0	Output Driver Programmability Bit 7. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: reserved / flip output polarity / flip output polarity
14	out_prog6	RW	0x1	Output Driver Programmability Bit 6. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: reserved / fmon = 17 Ohms / reserved
13	out_prog5	RW	0x0	Output Driver Programmability Bit 5. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: reserved / cross point lower / cross point tune
12	out_prog4	RW	0x0	Output Driver Programmability Bit 4. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: reserved / cross point increase for double termination / cross point tune
11	out_prog3	RW	0x0	Output Driver Programmability Bit 3. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: tristate OUTx / driver impedance -5% / cross point tune
10	out_prog2	RW	0x0	Output Driver Programmability Bit 2. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: tristate OUTxb / driver impedance +5% / cross point tune
9	out_prog1	RW	0x0	Output Driver Programmability Bit 1. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: flip OUTx polarity / amplitude -10% / amplitude -10%
8	out_prog0	RW	0x0	Output Driver Programmability Bit 0. When set to 1, controls the output driver as follows according to CMOS mode / LPHCSL mode / LVDS mode: flip OUTxb polarity / amplitude +5% / amplitude +5%
7	sel_fm_drv_predrv	RW	0x0	Output Driver Frequency Monitoring Control. Control signal for each output. Selects between driver or predriver to monitor output frequency. 0x0 = driver 0x1 = pre-driver
6	out_lpamp	RW	0x0	Output Driver LPHCSL amplitude control. Controls the amplitude of the output driver when LPHCSL mode is selected. 0x0 = 800mV 0x1 = 900mV
5	out_lpsr	RW	0x1	Output Driver LPHCSL slew rate control. Controls the slew rate of the output driver when LPHCSL mode is selected. Slew rates are measured from -150mV to +150mV from crossing point. 0x0 = slow, 2-4 V/ns 0x1 = fast, >4 V/ns
4	out_lpimp	RW	0x1	Output Driver LPHCSL impedance control. Controls the output impedance of the output driver when LPHCSL mode is selected. 0x0 = 85ohm 0x1 = 100ohm

ODRV_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3:2	out_cmdrv	RW	0x3	Output Driver CMOS slew rate control. Controls the slew rate of the output driver (in V/ns) when CMOS mode is selected, according to the supply voltage level of 3.3V / 2.5V / 1.8V: 0x0 = 4.2 / 2.7 / 1.8 0x1 = 2.7 / 1.5 / 1.8 0x2 = 2.7 / 1.5 / 1.8 0x3 = 3.4 / 2.0 / 1.9
1:0	out_mode	RW	0x0	Output Driver type. Selects the output driver type. 0x0 = LPHCSL 0x1 = LVDS 0x2 = LVDS 0x3 = CMOS

3.15 BANK

Output bank control registers.

Table 17. BANK Register Index

Offset (Hex)	Register Module Base Address: 0x1C0	
	Register Name	Register Description
0x0	OUT_BANK_CNFG	Output Bank Configuration, Powerdown, and Source

3.15.1 OUT_BANK_CNFG

Output Bank Configuration, Powerdown, and Source.

OUT_BANK_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:6	vdet_cnf	RW	0x1	Output bank trip point control. These bits control the VDD Detect Trip Point for each output bank.
5	out_fm_switch	RW	0x1	Enable frequency monitor feedback switch. This bit enables the analog path for the output frequency monitoring switch for each bank. 0x0 = disabled 0x1 = Analog output frequency monitoring switch enabled
4	bank_pd	RW	0x0	Output Bank Power Down. Powers down the output bank by turning off the regulator. 0x0 = powered up 0x1 = powered down
3	reserved	RO	0x0	Reserved

OUT_BANK_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
2:0	output_bank_src	RW	0x5	Output Bank Source. Sets the clock source of each output bank. Some configurations may be reserved based on table Output Bank Source Mapping. When the APLL reference clock is selected (option 0x7), the selected crystal input for the APLL is used as the source. 0x0 = LP FOD0 0x1 = LP FOD1 0x2 = IOD1 0x3 = IOD0 0x4 = HP FOD0 0x5 = HP FOD1 0x6 = HP FOD2 0x7 = APLL ref clock

3.16 GPI

GPI control registers.

Table 18. GPI Register Index

Offset (Hex)	Register Module Base Address: 0x1F0	
	Register Name	Register Description
0x0	GPI_CNFG	GPI Configuration

3.16.1 GPI_CNFG

GPI Configuration.

GPI_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	reserved	RO	0x0	Reserved
6	gpi_pol	RW	0x0	GPI Polarity. Sets the active polarity. This bit is ignored if gpi_func configures the pin as a clock input. 0x0 = active high 0x1 = active low
5	gpi_pull	RW	0x0	GPI Pull. Sets the internal pull-down mode. This bit is ignored and the internal pull-down is enabled if gpi_func configures the pin as a clock input. 0x0 = no pull 0x1 = pull-down

GPI_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
4:0	gpi_func	RW	0x1F	GPI Functions. Sets the general purpose input function. For option 0x7, the input status may be read back via I2C in gpi0_sts/gpi1_sts 0x0 = OE[0], input, enable output drivers in OE group 0 0x1 = OE[1], input, enable output drivers in OE group 1 0x2 = OE[2], input, enable output drivers in OE group 2 0x3 = OE[3], input, enable output drivers in OE group 3 0x4 = OE[4], input, enable output drivers in OE group 4 0x5 = GOE, input, enable all output drivers 0x7 = GPI, input 0x1F = GPI function disabled, pin used as clock input

3.17 GPIO

GPIO control registers.

Table 19. GPIO Register Index

Offset (Hex)	Register Module Base Address: 0x200	
	Register Name	Register Description
0x0	GPIO_CNFG	GPIO Configuration

3.17.1 GPIO_CNFG

GPIO Configuration.

GPIO_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:12	reserved	RO	0x0	Reserved
11	gpo_sync	RW	0x1	GPO Sync outputs with system clock. GPO are synced with system clock when pad is configured as an output. 0x0 = not synced with system clock 0x1 = synced with system clock
10:9	gpo_drv	RW	0x0	GPO Drive Strength. Applies to the pad when configured as an output (gpio_type is 0x0 or 0x2). Drive strength increases as this setting increases. Open-drain mode (gpio_type is 0x0) 0x0: I2C: 1.8V Standard mode, 2.5V/3.3V Standard & Fast mode 0x1: I2C: 1.8V Fast mode 0x2: reserved 0x3: I2C: 1.8V/2.5V/3.3V Fast-mode Plus Push-pull mode only for GPIO0 (gpio_type is 0x2) 0x0: for 3.3V power 0x1: for 2.5V power 0x2: for 1.8V power 0x3: for 1.5V power (reserved)

GPIO_CNFG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
8:7	gpio_type	RW	0x1	GPIO type. Sets the direction and type following reset Push pull output (option 0x2) is only supported for GPIO0. 0x0 = output (open-drain) 0x1 = input 0x2 = push pull output (driven high/low)
6	gpio_pol	RW	0x1	GPIO Polarity. Sets the active polarity. 0x0 = active high 0x1 = active low
5	gpio_pull	RW	0x1	GPIO Pull. Sets the internal pull-down mode 0x0 = no pull 0x1 = pull-down
4:0	gpio_func	RW	0x7	GPIO Functions. Sets the general purpose input/output function. Additional information for options: * option 0x7: input status may be read back via I2C in gpio0_sts-gpio6_sts * option 0x8: used to control external functions (such as LEDs). The output value is set in gpo0_ctrl-gpo6_ctrl. * option 0x10: the clock rate is set by gpio_fault_clock_div * option 0x11: the clock rate is set by gpio_int_clock_div * option 0x1F: this is for GPIO0 only 0x0 = OE[0], input, enable output drivers in OE group 0 0x1 = OE[1], input, enable output drivers in OE group 1 0x2 = OE[2], input, enable output drivers in OE group 2 0x3 = OE[3], input, enable output drivers in OE group 3 0x4 = OE[4], input, enable output drivers in OE group 4 0x5 = GOE, input, enable all output drivers 0x6 = Primary xtal disable, input 0x7 = GPI, input 0x8 = GPO, output 0x9 = FAULT, output
	gpio_func (continued)			0xA = INT, output 0xB = apll_lock_sts, output 0xC = Crystal 0 los_sts, output 0xD = Crystal 1 los_sts, output 0xE = device_ready, output 0xF = i2c_crc_err, output 0x10 = toggle for no FAULT, static for FAULT 0x11 = toggle for no INT, static for INT 0x1F = test clock according to test_clock_sel

3.18 INT

Interrupt and fault registers.

Table 20. INT Register Index

Offset (Hex)	Register Module Base Address: 0x220	
	Register Name	Register Description
0x0	AUTO_ACTION_EN	Automatic Action Enables
0x4	INT_EN	Interrupt Enable
0x8	FAULT_EN	Fault Enable
0xC	DEVICE_EVENT	Device Event Latched Status
0x10	MISC_EVENT	Miscellaneous Latched Event Status
0x14	EVENT_GEN	Event Generation
0x18	MON_EN	Monitor Enables
0x1C	SCRATCH0	Scratch Register

3.18.1 AUTO_ACTION_EN

Automatic Action Enables.

AUTO_ACTION_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:29	reserved	RO	0x0	Reserved
28	vco_cal_timeout_action_en	RW	0x0	VCO Calibration Timeout Automatic Action Enable. When this field is set to 1, the vco_cal_timeout event will trigger safe if this event occurs and its fault_en bit is set.
27	reserved	RO	0x0	Reserved
26	otp_crc_err_action_en	RW	0x0	Configuration Loader Error Automatic Action Enable. When this field is set to 1, the otp_crc_err event will trigger safe if this event occurs and its fault_en bit is set.
25	i2c_crc_err_action_en	RW	0x0	I2C CRC Error Automatic Action Enable. When this field is set to 1, the i2c_crc_err event will trigger safe if this event occurs and its fault_en bit is set.
24	csr_sig_reload_fail_action_en	RW	0x0	CSR Signature Check Reload Automatic Action Enable. When this field is set to 1, the csr_sig_reload_fail event will trigger safe if this event occurs and its fault_en bit is set.
23	csr_sig_fail_action_en	RW	0x0	CSR Signature Check Failure Automatic Action Enable. When this field is set to 1, the csr_sig_fail event will trigger safe if this event occurs and its fault_en bit is set.
22	dual_xtal_fail_action_en	RW	0x0	Dual Crystal Failure Automatic Action Enable. When this field is set to 1, the dual_xtal_fail event will trigger safe if this event occurs and its fault_en bit is set.
21	xtal_switch_action_en	RW	0x0	Crystal Switch Event Automatic Action Enable. When this field is set to 1, the xtal_switch event will trigger safe if this event occurs and its fault_en bit is set.

AUTO_ACTION_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
20:9	freq_action_en	RW	0x0	Output Clock Frequency Automatic Action Automatic Action Enable. When a bit in this field is set to 1, if the corresponding freqX_evt occurs, the output will be disabled. Safe state also will be triggered if the corresponding freqX_evt occurs and its fault_en bit is set. Bit [11] = freq11_evt ... Bit [0] = freq0_evt
8:7	xtal_st_err_action_en	RW	0x0	Crystal Short Term Automatic Action Automatic Action Enable. When a bit in this field is set to 1, the corresponding xtalX_st_err event will trigger safe if this event occurs and its fault_en bit is set. [Bit 1] = xtal1_st_err [Bit 0] = xtal0_st_err
6	xtal_ppm_err_action_en	RW	0x0	Crystal PPM Automatic Action Error Automatic Action Enable. When this field is set to 1, the xtal_ppm_err event will trigger safe if this event occurs and its fault_en bit is set.
5	xtal_ppm_warn_action_en	RW	0x0	Crystal PPM Automatic Action Warning Automatic Action Enable. When this field is set to 1, the xtal_ppm_warn event will trigger safe if this event occurs and its fault_en bit is set.
4:3	los_action_en	RW	0x0	Crystal Loss-of-Signal Automatic Action Enable. When a bit in this field is set to 1, the corresponding losX_evt event will trigger safe if this event occurs and its fault_en bit is set. [Bit 1] = los1_evt [Bit 0] = los0_evt
2	apll_lol_action_en	RW	0x0	APLL Loss-of-Lock Automatic Action enable. When this field is set to 1, the apll_lol event will trigger safe if this event occurs and its fault_en bit is set.
1	reserved	RO	0x0	Reserved
0	post_fail_action_en	RW	0x0	POST Failure Automatic Action Enable. When this field is set to 1, the post_fail event will trigger safe if this event occurs and its fault_en bit is set.

3.18.2 INT_EN

Interrupt Enable.

INT_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31	device_int_en	RW	0x0	Device Interrupt Enable. Overall device interrupt enable. When this field is set to 1, the device interrupt is asserted on the GPIO (selected by gpio_func) while device_int_sts is 1.
30:29	reserved	RO	0x0	Reserved
28	vco_cal_timeout_int_en	RW	0x0	VCO Calibration Timeout Interrupt Enable. When this field is set to 1, the vco_cal_timeout bit contributes to the device interrupt.
27	otp_load_fail_int_en	RW	0x0	Configuration Loader Failure Interrupt Enable. When this field is set to 1, the otp_load_fail bit contributes to the device interrupt.
26	otp_crc_err_int_en	RW	0x0	Configuration Loader Error Interrupt Enable. When this field is set to 1, the otp_crc_err bit contributes to the device interrupt.

INT_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
25	i2c_crc_err_int_en	RW	0x0	I2C CRC Error Interrupt Enable. When this field is set to 1, the i2c_crc_err bit contributes to the device interrupt.
24	csr_sig_reload_fail_int_en	RW	0x0	CSR Signature Check Reload Interrupt Enable. When this field is set to 1, the csr_sig_reload_fail bit contributes to the device interrupt.
23	csr_sig_fail_int_en	RW	0x0	CSR Signature Check Failure Interrupt Enable. When this field is set to 1, the csr_sig_fail bit contributes to the device interrupt.
22	dual_xtal_fail_int_en	RW	0x0	Dual Crystal Failure Interrupt Enable. When this field is set to 1, the dual_xtal_fail bit contributes to the device interrupt.
21	xtal_switch_int_en	RW	0x0	Crystal Switch Event Interrupt Enable. When this field is set to 1, the xtal_switch bit contributes to the device interrupt.
20:9	freq_int_en	RW	0x0	Output Clock Frequency Monitor Interrupt Enable. When a bit in this field is set to 1, the corresponding freqX_evt bit contributes to the device interrupt. Bit [11] = freq11_evt ... Bit [0] = freq0_evt
8:7	xtal_st_err_int_en	RW	0x0	Crystal Short Term Monitor Interrupt Enable. When a bit in this field is set to 1, the corresponding xtalX_st_err bit contributes to the device interrupt. [Bit 1] = xtal1_st_err [Bit 0] = xtal0_st_err
6	xtal_ppm_err_int_en	RW	0x0	Crystal PPM Monitor Error Interrupt Enable. When this field is set to 1, the xtal_ppm_err bit contributes to the device interrupt.
5	xtal_ppm_warn_int_en	RW	0x0	Crystal PPM Monitor Warning Interrupt Enable. When this field is set to 1, the xtal_ppm_warn bit contributes to the device interrupt.
4:3	los_int_en	RW	0x0	Crystal Loss-of-Signal Interrupt Enable. When a bit in this field is set to 1, the corresponding losX_evt bit contributes to the device interrupt. [Bit 1] = los1_evt [Bit 0] = los0_evt
2	apll_lol_int_en	RW	0x0	APLL Loss-of-Lock interrupt enable. When this field is set to 1, the apll_lol bit contributes to the device interrupt.
1	reserved	RO	0x0	Reserved
0	post_fail_int_en	RW	0x0	POST Failure Interrupt Enable. When this field is set to 1, the post_fail bit contributes to the device interrupt.

3.18.3 FAULT_EN

Fault Enable.

FAULT_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31	device_fault_en	RW	0x0	Device Fault Enable. Overall device fault enable. When this field is set to 1, the device fault is asserted on the GPIO (selected by gpio_func) and to set the part into safe state while device_fault_sts is 1.
30:29	reserved	RO	0x0	Reserved
28	vco_cal_timeout_fault_en	RW	0x0	VCO Calibration Timeout Fault Enable. When this field is set to 1, the vco_cal_timeout bit contributes to the device fault.

FAULT_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
27	otp_load_fail_fault_en	RW	0x0	Configuration Loader Failure Fault Enable. When this field is set to 1, the otp_load_fail bit contributes to the device fault.
26	otp_crc_err_fault_en	RW	0x0	Configuration Loader Error Fault Enable. When this field is set to 1, the otp_crc_err bit contributes to the device fault.
25	i2c_crc_err_fault_en	RW	0x0	I2C CRC Error Fault Enable. When this field is set to 1, the i2c_crc_err bit contributes to the device fault.
24	csr_sig_reload_fail_fault_en	RW	0x0	CSR Signature Check Reload Fault Enable. When this field is set to 1, the csr_sig_reload_fail bit contributes to the device fault.
23	csr_sig_fail_fault_en	RW	0x0	CSR Signature Check Failure Fault Enable. When this field is set to 1, the csr_sig_fail bit contributes to the device fault.
22	dual_xtal_fail_fault_en	RW	0x0	Dual Crystal Failure Fault Enable. When this field is set to 1, the dual_xtal_fail bit contributes to the device fault.
21	xtal_switch_fault_en	RW	0x0	Crystal Switch Event Fault Enable. When this field is set to 1, the xtal_switch bit contributes to the device fault.
20:9	freq_fault_en	RW	0x0	Output Clock Frequency Monitor Fault Enable. When a bit in this field is set to 1, the corresponding freqX_evt bit contributes to the device fault. Bit [11] = freq11_evt ... Bit [0] = freq0_evt
8:7	xtal_st_err_fault_en	RW	0x0	Crystal Short Term Monitor Fault Enable. When a bit in this field is set to 1, the corresponding xtalX_st_err bit contributes to the device fault. [Bit 1] = xtal1_st_err [Bit 0] = xtal0_st_err
6	xtal_ppm_err_fault_en	RW	0x0	Crystal PPM Monitor Error Fault Enable. When this field is set to 1, the xtal_ppm_err bit contributes to the device fault
5	xtal_ppm_warn_fault_en	RW	0x0	Crystal PPM Monitor Warning Fault Enable. When this field is set to 1, the xtal_ppm_warn bit contributes to the device fault
4:3	los_fault_en	RW	0x0	Crystal Loss-of-Signal Fault Enable. When a bit in this field is set to 1, the corresponding losX_evt bit contributes to the device fault. [Bit 1] = los1_evt [Bit 0] = los0_evt
2	apll_lol_fault_en	RW	0x0	APLL Loss-of-Lock Fault enable. When this field is set to 1, the apll_lol bit contributes to the device fault.
1	reserved	RO	0x0	Reserved
0	post_fail_fault_en	RW	0x0	POST Failure Fault Enable. When this field is set to 1, the post_fail bit contributes to the device fault.

3.18.4 DEVICE_EVENT

Device Event Latched Status.

DEVICE_EVENT Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:29	reserved	RO	0x0	Reserved
28	vco_cal_timeout	RW1C	0x0	VCO Calibration Timeout latched status. When high, indicates the VCO Calibration timed out or no XTAL is enabled for the calibration to use and VCO Calibration was not bypassed.
27	otp_load_fail	RW1C	0x0	Configuration Loader Failure latched status. When high, indicates the OTP load failed during device startup. Cleared by writing it to 1.
26	otp_crc_err	RW1C	0x0	Configuration Loader Error latched status. When high, indicates the OTP load encountered one or more CRC errors during device startup. Cleared by writing it to 1.
25	i2c_crc_err	RW1C	0x0	I2C CRC Error Event latched status. Set to 1 when an I2C CRC error is detected.
24	csr_sig_reload_fail	RW1C	0x0	CSR Signature Check Reload latched status. Set to 1 if the CRC-32 value calculated during a CSR check (readable in csr_sig_calc) does not match the expected value programmed in csr_sig_exp, and csr_sig_err_mode is set to 1 and the reload of the registers fails.
23	csr_sig_fail	RW1C	0x0	CSR Signature Check Failure latched status. Set to 1 if the CRC-32 value calculated during a CSR check (readable in csr_sig_calc) does not match the expected value programmed in csr_sig_exp, and csr_sig_err_mode is set to 0.
22	dual_xtal_fail	RW1C	0x0	Dual Crystal Failure latched status. Set to 1 when automatic crystal selection is enabled, the selected crystal becomes invalid, and the other crystal is also invalid. The device does not switch to the other crystal in this case.
21	xtal_switch	RW1C	0x0	Crystal Switch Event latched status. Set to 1 when the device automatically switches the crystal selected for the APLL reference clock.
20	freq11_evt	RW1C	0x0	Output Clock 11 Frequency Monitor event latched status. Set to 1 when the Output Clock 11 (True or Complement) Frequency Monitor detects a failure.
19	freq10_evt	RW1C	0x0	Output Clock 10 Frequency Monitor event latched status. Set to 1 when the Output Clock 10 (True or Complement) Frequency Monitor detects a failure.
18	freq9_evt	RW1C	0x0	Output Clock 9 Frequency Monitor event latched status. Set to 1 when the Output Clock 9 (True or Complement) Frequency Monitor detects a failure.
17	freq8_evt	RW1C	0x0	Output Clock 8 Frequency Monitor event latched status. Set to 1 when the Output Clock 8 (True or Complement) Frequency Monitor detects a failure.
16	freq7_evt	RW1C	0x0	Output Clock 7 Frequency Monitor event latched status. Set to 1 when the Output Clock 7 (True or Complement) Frequency Monitor detects a failure.
15	freq6_evt	RW1C	0x0	Output Clock 6 Frequency Monitor event latched status. Set to 1 when the Output Clock 6 (True or Complement) Frequency Monitor detects a failure.
14	freq5_evt	RW1C	0x0	Output Clock 5 Frequency Monitor event latched status. Set to 1 when the Output Clock 5 (True or Complement) Frequency Monitor detects a failure.

DEVICE_EVENT Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
13	freq4_evt	RW1C	0x0	Output Clock 4 Frequency Monitor event latched status. Set to 1 when the Output Clock 4 (True or Complement) Frequency Monitor detects a failure.
12	freq3_evt	RW1C	0x0	Output Clock 3 Frequency Monitor event latched status. Set to 1 when the Output Clock 3 (True or Complement) Frequency Monitor detects a failure.
11	freq2_evt	RW1C	0x0	Output Clock 2 Frequency Monitor event latched status. Set to 1 when the Output Clock 2 (True or Complement) Frequency Monitor detects a failure.
10	freq1_evt	RW1C	0x0	Output Clock 1 Frequency Monitor event latched status. Set to 1 when the Output Clock 1 (True or Complement) Frequency Monitor detects a failure.
9	freq0_evt	RW1C	0x0	Output Clock 0 Frequency Monitor event latched status. Set to 1 when the Output Clock 0 (True or Complement) Frequency Monitor detects a failure.
8	xtal1_st_err	RW1C	0x0	Crystal 1 Short Term Monitor Error Event latched status. Set to 1 when the crystal short term monitor detects that the crystal 1 frequency exceeds the threshold (see st_max_thresh).
7	xtal0_st_err	RW1C	0x0	Crystal 0 Short Term Monitor Error Event latched status. Set to 1 when the crystal short term monitor detects that the crystal 0 frequency exceeds the threshold (see st_max_thresh).
6	xtal_ppm_err	RW1C	0x0	Crystal PPM Monitor Error Event latched status. Set to 1 when the crystal PPM monitor detects an error condition (see ppm_err_thresh).
5	xtal_ppm_warn	RW1C	0x0	Crystal PPM Monitor Warning Event latched status. Set to 1 when the crystal PPM monitor detects a warning condition (see ppm_warn_thresh).
4	los1_evt	RW1C	0x0	Crystal 1 Loss-of-Signal Event latched status. Set to 1 when the Crystal 1 LOS monitor detects Loss Of Signal. 0x0 = Loss-of-signal not detected since the last time the bit was cleared 0x1 = Loss-of-signal detected since the last time the bit was cleared
3	los0_evt	RW1C	0x0	Crystal 0 Loss-of-Signal Event latched status. Set to 1 when the Crystal 0 LOS monitor detects Loss Of Signal. 0x0 = Loss-of-signal not detected since the last time the bit was cleared 0x1 = Loss-of-signal detected since the last time the bit was cleared
2	apll_lol	RW1C	0x0	APLL Loss-of-lock event latched status. Set to 1 when the APLL lock status transitions from locked to unlocked.
1	reserved	RO	0x0	Reserved
0	post_fail	RW1C	0x0	POST Failure latched status. Set to 1 when POST detects a failure.

3.18.5 MISC_EVENT

Miscellaneous Latched Event Status.

MISC_EVENT Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	reserved	RO	0x0	Reserved
6	apll_rail_high_evt	RW1C	0x0	APLL Rail High event latched status. Set to 1 when the APLL lock detects a rail high status. Once asserted, this bit will remain asserted until cleared by a write of '1' to this bit position. This bit cannot contribute to an interrupt or fault.
5	apll_rail_low_evt	RW1C	0x0	APLL Rail Low event latched status. Set to 1 when the APLL lock detects a rail low status. Once asserted, this bit will remain asserted until cleared by a write of '1' to this bit position. This bit cannot contribute to an interrupt or fault.
4	otp_manual_rdy	RW1C	0x0	OTP Manual ready indicator latched status. When high, indicates an OTP manual request (including Program Assist) completed. Cleared by writing it to 1. This bit cannot contribute to an interrupt or fault.
3	status_latched	RW1C	0x0	OTP macro output pin latched status. Latched value of the OTP macro output pin. Can be cleared by writing 1 to it. If STATUS is still high when clearing is attempted, this bit will immediately be set to 1 again. Cannot contribute to the device interrupt or fault output.
2	vpp_error	RW1C	0x0	OTP VPP error. This error bit signals that the internal charge pump was idle longer than the maximum time permitted. See the OTP datasheet for details. This bit gets cleared by writing one to it. It cannot be cleared unless the internal condition has gone away (i.e., VPP_MON has been de-asserted). Cannot contribute to the device interrupt or fault output.
1	pgm_assist_fail	RW1C	0x0	Program Assist failure. When high, indicates that the Program Assist sequence failed to program one or more bits in the OTP word. Cannot contribute to the device interrupt or fault output.
0	otp_config_empty	RW1C	0x0	OTP Load of Empty Configuration. When high, indicates the OTP load attempted to load a configuration that did not select any blocks. Cleared by writing it to 1. Cannot contribute to the device interrupt or fault output.

3.18.6 EVENT_GEN

Event Generation.

EVENT_GEN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:29	reserved	RO	0x0	Reserved
28	vco_cal_timeout_gen	WO	0x0	VCO Calibration Timeout Event Generate. When this field is set to 1, the vco_cal_timeout bit is set. This field always reads 0.
27	otp_load_fail_gen	WO	0x0	Configuration Loader Failure Event Generate. When this field is set to 1, the otp_load_fail bit is set. This field always reads 0.
26	otp_crc_err_gen	WO	0x0	Configuration Loader Error Event Generate. When this field is set to 1, the otp_crc_err bit is set. This field always reads 0.
25	i2c_crc_err_gen	WO	0x0	I2C CRC Error Event Generate. When this field is set to 1, the i2c_crc_err bit is set. This field always reads 0.

EVENT_GEN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
24	csr_sig_reload_fail_gen	WO	0x0	CSR Signature Check Reload Event Generate. When this field is set to 1, the csr_sig_reload_fail bit is set. This field always reads 0.
23	csr_sig_fail_gen	WO	0x0	CSR Signature Check Failure Event Generate. When this field is set to 1, the csr_sig_fail bit is set. This field always reads 0.
22	dual_xtal_fail_gen	WO	0x0	Dual Crystal Failure Event Generate. When this field is set to 1, the dual_xtal_fail bit is set. This field always reads 0.
21	xtal_switch_gen	WO	0x0	Crystal Switch Event Generate. When this field is set to 1, the xtal_switch bit is set. This field always reads 0.
20	freq11_gen	WO	0x0	Output Clock 11 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq11_evt bit is set. This field always reads 0.
19	freq10_gen	WO	0x0	Output Clock 10 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq10_evt bit is set. This field always reads 0.
18	freq9_gen	WO	0x0	Output Clock 9 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq9_evt bit is set. This field always reads 0.
17	freq8_gen	WO	0x0	Output Clock 8 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq8_evt bit is set. This field always reads 0.
16	freq7_gen	WO	0x0	Output Clock 7 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq7_evt bit is set. This field always reads 0.
15	freq6_gen	WO	0x0	Output Clock 6 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq6_evt bit is set. This field always reads 0.
14	freq5_gen	WO	0x0	Output Clock 5 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq5_evt bit is set. This field always reads 0.
13	freq4_gen	WO	0x0	Output Clock 4 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq4_evt bit is set. This field always reads 0.
12	freq3_gen	WO	0x0	Output Clock 3 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq3_evt bit is set. This field always reads 0.
11	freq2_gen	WO	0x0	Output Clock 2 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq2_evt bit is set. This field always reads 0.
10	freq1_gen	WO	0x0	Output Clock 1 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq1_evt bit is set. This field always reads 0.
9	freq0_gen	WO	0x0	Output Clock 0 Frequency Monitor Event Generate. When a bit in this field is set to 1, the freq0_evt bit is set. This field always reads 0.
8	xtal1_st_err_gen	WO	0x0	Crystal 1 Short Term Monitor Event Generate. When this field is set to 1, the xtal1_st_err bit is set. This field always reads 0.
7	xtal0_st_err_gen	WO	0x0	Crystal 0 Short Term Monitor Event Generate. When this field is set to 1, the xtal0_st_err bit is set. This field always reads 0.
6	xtal_ppm_err_gen	WO	0x0	Crystal PPM Monitor Error Event Generate. When this field is set to 1, the xtal_ppm_err bit is set. This field always reads 0.
5	xtal_ppm_warn_gen	WO	0x0	Crystal PPM Monitor Warning Event Generate. When this field is set to 1, the xtal_ppm_warn bit is set. This field always reads 0.
4	los1_gen	WO	0x0	Crystal 1 Loss-of-Signal Event Generate. When a bit in this field is set to 1, the los1_evt bit is set. This field always reads 0.
3	los0_gen	WO	0x0	Crystal 0 Loss-of-Signal Event Generate. When a bit in this field is set to 1, the los0_evt bit is set. This field always reads 0.

EVENT_GEN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
2	apll_lol_gen	WO	0x0	APLL Loss-of-Lock Event Generate. When this field is written to 1, the apll_lol bit is set. This field always reads 0.
1	reserved	RO	0x0	Reserved
0	post_fail_gen	WO	0x0	POST Failure Event Generate. When this field is set to 1, the post_fail bit is set. This field always reads 0.

3.18.7 MON_EN

Monitor Enables.

MON_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:29	reserved	RO	0x0	Reserved
28	vco_cal_timeout_mon_en	RW	0x1	VCO Calibration Timeout Monitor Enable. When this field is set to 1, the vco_cal_timeout is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
27	reserved	RO	0x0	Reserved
26	otp_crc_err_mon_en	RW	0x1	Configuration Loader Error Monitor Enable. When this field is set to 1, the otp_crc_err is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
25	i2c_crc_err_mon_en	RW	0x1	I2C CRC Error Monitor Enable. When this field is set to 1, the i2c_crc_err is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
24	csr_sig_reload_fail_mon_en	RW	0x1	CSR Signature Check Reload Monitor Enable. When this field is set to 1, the csr_sig_reload_fail is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
23	csr_sig_fail_mon_en	RW	0x1	CSR Signature Check Failure Monitor Enable. When this field is set to 1, the csr_sig_fail is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
22	dual_xtal_fail_mon_en	RW	0x1	Dual Crystal Failure Monitor Enable. When this field is set to 1, the dual_xtal_fail is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
21	xtal_switch_mon_en	RW	0x1	Crystal Switch Event Monitor Enable. When this field is set to 1, the xtal_switch is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
20:9	freq_mon_en	RW	0xFFF	Output Clock Frequency Monitor Enable. When a bit in this field is set to 1, the corresponding freqX_evt is monitored for errors and can set the mapped bit in the DEVICE_EVENT register. Bit [11] = freq11_evt ... Bit [0] = freq0_evt

MON_EN Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
8:7	xtal_st_err_mon_en	RW	0x3	Crystal Short Term Monitor Enable. When a bit in this field is set to 1, the corresponding xtalX_st_err is monitored for errors and can set the mapped bit in the DEVICE_EVENT register. Both crystals are needed for the short term monitor to function, so both xtal_st_err_mon_en bits should be enabled (set to 1) for dual crystal cases or both should be disabled (set to 0) for single crystal cases or if the short term monitor feature is not desired. [Bit 1] = xtal1_st_err [Bit 0] = xtal0_st_err
6	xtal_ppm_err_mon_en	RW	0x1	Crystal PPM Monitor Error Monitor Enable. When this field is set to 1, the xtal_ppm_err bit contributes to the device fault
5	xtal_ppm_warn_mon_en	RW	0x1	Crystal PPM Monitor Warning Monitor Enable. When this field is set to 1, the xtal_ppm_warn bit contributes to the device fault
4:3	los_mon_en	RW	0x3	Crystal Loss-of-Signal Monitor Enable. When a bit in this field is set to 1, the corresponding losX_evt is monitored for errors and can set the mapped bit in the DEVICE_EVENT register. [Bit 1] = los1_evt [Bit 0] = los0_evt
2	apll_lol_mon_en	RW	0x1	APLL Loss-of-Lock Monitor enable. When this field is set to 1, the apll_lol is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.
1	reserved	RO	0x0	Reserved
0	post_fail_mon_en	RW	0x1	POST Failure Monitor Enable. When this field is set to 1, the post_fail is monitored for errors and can set the mapped bit in the DEVICE_EVENT register.

3.18.8 SCRATCH0

Scratch Register.

SCRATCH0 Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:0	scratch0	RW	0x0	Scratch register. For arbitrary software use.

3.19 STATUS

Status registers.

Table 21. STATUS Register Index

Offset (Hex)	Register Module Base Address: 0x280	
	Register Name	Register Description
0x0	CSR_SIG_STS	CSR Signature Status
0x4	DEVICE_STS	Device Status
0x8	STARTUP_STS	Startup Bond/GPI/GPIO Status
0xB	SSI_STS	I2C CRC Error Count
0xC	GPIO_STS	GPI/GPIO Status

Table 21. STATUS Register Index

Offset (Hex)	Register Module Base Address: 0x280	
	Register Name	Register Description
0xE	BIAS_STS	Bias Status
0x10	APLL_STS	APLL Status
0x11	VCO_CAL_STS	VCO Calibration Status
0x12	VCO_TRIM_STS	VCO Trim Calibration Status
0x14	ANA_SPARE_STS	Analog Spare Status and Voltage Detector Status
0x16	LOSMON_STS	LOS Monitor Status
0x17	PPM_MON_STS	PPM Monitor Status
0x18	FREQMON_STS	Output Frequency Monitor Status
0x1C	OTP_STS	OTP Status
0x1D	OTP_ERR_CNT	OTP CRC Error Count
0x1E	OTP_PARAM	OTP Parameters
0x20	DIG_POST_STS	Digital POST Status
0x24	ANA_POST_STS	Analog POST Status
0x28	DIG_POST_FSM_STS	Digital POST State Machine Status
0x2A	ANA_POST_FSM_STS	Digital POST State Machine Status

3.19.1 CSR_SIG_STS

CSR Signature Status.

CSR_SIG_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:0	csr_sig_calc	RO	0x0	Calculated CSR Signature. Provides the CRC-32 value calculated during the last CSR check.

3.19.2 DEVICE_STS

Device Status.

DEVICE_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:26	reserved	RO	0x0	Reserved
25	device_int_sts	RO	0x0	Device interrupt status. Overall device interrupt status. This bit is the OR of all the event bits in the DEVICE_EVENT register after masking by their respective interrupt enable bits in the INT_EN register. This bit is masked by device_int_en. The resulting signal can be output on the assigned GPIO pin.
24	device_fault_sts	RO	0x0	Device fault status. Overall device fault status. This bit is the OR of all the event bits in the DEVICE_EVENT register after masking by their respective fault enable bits in the FAULT_EN register. This bit is masked by device_fault_en. The resulting signal can be output on the assigned GPIO pin and used to put the part into safe state.

DEVICE_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
23:20	reserved	RO	0x0	Reserved
19	lbist_done	RO	0x0	Logic BIST Done Status. When set, indicates that the device has completed logic BIST.
18	reset_done	RO	0x0	Reset Done Status. When set, indicates that the device has completed its full boot sequence.
17:14	startup_seq_sts	RO	0x0	Startup Sequence Status. Status related to the startup sequence. This field is intended for debug purposes only. Bit 0: Bias calibration timeout (2ms) Bit 1: Configuration load timeout (15ms). Bit 2: APLL lock timeout (2ms) Bit 3: VCO Calibration timeout (programmable in vco_cal_timer)
13	ssc1_active	RO	0x0	Active status of SSC1. Indicates whether the SSC engine 1 is active. 0x0 = SSC is inactive or is done 0x1 = SSC is active
12	ssc0_active	RO	0x0	Active status of SSC0. Indicates whether the SSC engine 0 is active. 0x0 = SSC is inactive or is done 0x1 = SSC is active
11	ana_post_done	RO	0x0	Analog BIST Done. Set to 1 when analog logic BIST completes, if enabled to run during the POST by ana_post_en. Will be implemented for Rev A.
10	dig_post_done	RO	0x0	Digital BIST Done. Set to 1 when digital logic BIST completes, if enabled to run during the POST by dig_bist_en. Will be implemented for Rev A.
9	osc_fallback	RO	0x0	Power-on-Reset Ring Oscillator Fallback. Set to 1 if the system clock divider output does not begin toggling during the startup sequence and the reset controller muxes the ring oscillator clock onto the system clock instead.
8	xtal_sel_sts	RO	0x0	Selected Crystal Status. Indicates which crystal is currently selected. 0x0 = crystal 0 0x1 = crystal 1
7	device_ready	RO	0x0	Device Ready. Set to 1 when the OTP configuration load completes during the startup sequence.
6	config_reg_ro	RO	0x0	Configuration register read-only status. When this bit is 1, writes to configuration registers are ignored. Writes to bits of type RW1C, self-clearing bits, reg_lock_key and certain RW and RW1S bits always succeed; refer to Configuration Register Lock for more details. This will be implemented in Rev A. Use the reg_lock_key field (only in Rev A and later) to set/clear this bit.
5	otp_detect_se	RO	0x0	OTP Loader Detected Single-Ended Mode. When high, indicates that the OTP loader detected that the OTP image is configured for single-ended mode.
4	otp_config_valid	RO	0x0	Valid OTP User Configuration Loaded. Indicates that the user configuration in config_loaded was successfully loaded from OTP.
3:0	config_loaded	RO	0x0	User Configuration Loaded. Indicates the user configuration loaded from OTP/EEPROM on start-up or a dynamic configuration load. Note that on startup, the common configuration is always loaded prior to the user configuration.

3.19.3 STARTUP_STS

Startup Bond/GPI/GPIO Status.

STARTUP_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:10	reserved	RO	0x0	Reserved
9	bond_id	RO	0x0	Bond ID value. Value of bond ID die pads. bit [0] = BOND0
8:7	gpi_at_startup	RO	0x0	GPI Value Latched at Startup. Value of GPI pins latched at startup. Bit [1] = GPI1 Bit [0] = GPIO
6:0	gpio_at_startup	RO	0x0	GPIO Value Latched at Startup. Value of GPIO pins latched at startup. Bit [6] = GPIO6 ... bit [0] = GPIO0

3.19.4 SSI_STS

I2C CRC Error Count.

SSI_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:0	i2c_crc_err_cnt	RW	0x0	I2C CRC Error Counter. This counter increments each time the I2C interface detects a CRC error, and saturates at 0xFF. It is cleared by writing it to 0x0, and may be preset by writing the desired value. Preset may be used either as a debug tool.

3.19.5 GPIO_STS

GPI/GPIO Status.

GPIO_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:9	reserved	RO	0x0	Reserved
8	gpi1_sts	RO	0x0	GPI1 Status. Indicates the status of the GPI1 pin without latching and without applying optional polarity inversion (gpi_pol). If a pin is configured to be a reference clock input (see gpi_func), the status reads back as 0. pin = XOUT1_REFIN1b_GPI1
7	gpi0_sts	RO	0x0	GPIO Status. Indicates the status of the GPIO pin without latching and without applying optional polarity inversion (gpi_pol). If a pin is configured to be a reference clock input (see gpi_func), the status reads back as 0. pin = XIN1_REFIN1_GPIO
6	gpio6_sts	RO	0x0	GPIO6 Status. Indicates the status of the GPIO6 pin without latching and without applying optional polarity inversion (gpio_pol).
5	gpio5_sts	RO	0x0	GPIO5 Status. Indicates the status of the GPIO5 pin without latching and without applying optional polarity inversion (gpio_pol).
4	gpio4_sts	RO	0x0	GPIO4 Status. Indicates the status of the GPIO5 pin without latching and without applying optional polarity inversion (gpio_pol).

GPIO_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3	gpio3_sts	RO	0x0	GPIO3 Status. Indicates the status of the GPIO3 pin without latching and without applying optional polarity inversion (gpio_pol).
2	gpio2_sts	RO	0x0	GPIO2 Status. Indicates the status of the GPIO2 pin without latching and without applying optional polarity inversion (gpio_pol).
1	gpio1_sts	RO	0x0	GPIO1 Status. Indicates the status of the GPIO1 pin without latching and without applying optional polarity inversion (gpio_pol).
0	gpio0_sts	RO	0x0	GPIO0 Status. Indicates the status of the GPIO0 pin without latching and without applying optional polarity inversion (gpio_pol).

3.19.6 BIAS_STS

Bias Status.

BIAS_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:13	reserved	RO	0x0	Reserved
12	bias_cal_in	RO	0x0	Bias Calibration comparator value. Raw bias_cal_in value.
11:7	cnf_bias_cal_eff	RO	0x0	Bias Calibration effective configuration value. Indicates the configuration value selected as sent to the bias control circuit (i.e., including the offset as configured in bias_cnf_rescal_offset). Valid when bias_cal_done is set to 1.
6:2	cnf_bias_cal	RO	0x0	Bias Calibration configuration value. Indicates the configuration value selected by the bias calibration logic. Valid when bias_cal_done is set to 1.
1	bias_cal_fail	RO	0x0	Bias Calibration failed. Indicates whether bias calibration completed successfully. Valid when bias_cal_done is set to 1. 0x0 = Bias calibration succeeded 0x1 = Bias calibration failed
0	bias_cal_done	RO	0x0	Bias Calibration done. Indicates whether bias calibration is running: 0x0 = Bias calibration is in progress 0x1 = Bias calibration is completed

3.19.7 APLL_STS

APLL Status.

APLL_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:3	reserved	RO	0x0	Reserved
2	apll_rail_high_sts	RO	0x0	APLL Rail High real-time status. When high, indicates that the APLL is railed high.

APLL_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
1	apll_rail_low_sts	RO	0x0	APLL Rail Low real-time status. When high, indicates that the APLL is railed low.
0	apll_lock_sts	RO	0x0	APLL lock status. Set to 1 when the APLL is locked to its reference. 0x0 = unlocked 0x1 = locked

3.19.8 VCO_CAL_STS

VCO Calibration Status.

VCO_CAL_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	vco_cal_fail	RO	0x0	VCO Calibration failed. Indicates whether VCO calibration completed successfully. Valid when vco_cal_done is set to 1. 0x0 = VCO calibration succeeded 0x1 = VCO calibration failed
6	vco_cal_done	RO	0x0	VCO Calibration done. Indicates whether VCO calibration is running: 0x0 = VCO calibration is in progress 0x1 = VCO calibration is completed
5:0	vco_cap	RO	0x0	VCO Calibration frequency band. Indicates the frequency band selected by the VCO calibration logic. Valid when vco_cal_done is set to 1.

3.19.9 VCO_TRIM_STS

VCO Trim Calibration Status.

VCO_TRIM_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:2	reserved	RO	0x0	Reserved
1:0	vco_trim_val	RO	0x1	Coarse VCO Tuning Value. Indicates the current VCO trim value. This reflects the value of vco_trim when vco_trim_cal_en is set to 0. When vco_trim_cal_en is set to 1, this field indicates the value selected by the VCO calibration logic.

3.19.10 ANA_SPARE_STS

Analog Spare Status and Voltage Detector Status.

ANA_SPARE_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:7	ana_spare_sts	RO	0x0	Analog Spare Status Bits. Spare register bits connected to analog. Unused.
6	vddo6_sts	RO	0x0	Bank 6 voltage detector status. Trip point detection for bank 6. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled

ANA_SPARE_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
5	vddo5_sts	RO	0x0	Bank 5 voltage detector status. Trip point detection for bank 5. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled
4	vddo4_sts	RO	0x0	Bank 4 voltage detector status. Trip point detection for bank 4. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled
3	vddo3_sts	RO	0x0	Bank 3 voltage detector status. Trip point detection for bank 3. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled
2	vddo2_sts	RO	0x0	Bank 2 voltage detector status. Trip point detection for bank 2. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled
1	vddo1_sts	RO	0x0	Bank 1 voltage detector status. Trip point detection for bank 1. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled
0	vddo0_sts	RO	0x0	Bank 0 voltage detector status. Trip point detection for bank 0. 0x0 = Output driver 1.8V regulator is bypassed 0x1 = Output driver 1.8V regulator is enabled

3.19.11 LOSMON_STS

LOS Monitor Status.

LOSMON_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	reserved	RO	0x0	Reserved
3:2	xtal_invalid	RO	0x0	Crystal Clock Invalid status. Indicates whether this crystal is currently considered to be invalid. This occurs if the clock is disqualified by one or more of the Loss-of-Signal and Short Term monitors, or xtal_disable is set to 1. [Bit 1] = xtal1 invalid [Bit 0] = xtal0 invalid 0x0 = Crystal is valid 0x1 = Crystal is invalid
1:0	los_sts	RO	0x0	Loss-of-Signal status. Current value of the LOS status from the monitor. [Bit 1] = Crystal 1 LOS monitor [Bit 0] = Crystal 0 LOS monitor 0x0 = Clock meets the monitoring criteria 0x1 = Loss-of-signal detected

3.19.12 PPM_MON_STS

PPM Monitor Status.

PPM_MON_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:0	xtal_ppm_diff	RO	0x0	PPM difference. Shows the raw ppm difference in 2ppm/lb measured by the crystal ppm monitoring block. This register is updated every 500 thousand xtal clk cycles, so the update rate depends on xtal clk frequency. For example: - 8MHz xtal clk, updates every 62.5ms - 62.5MHz xtal clk, updates every 8ms

3.19.13 FREQMON_STS

Output Frequency Monitor Status.

FREQMON_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:24	reserved	RO	0x0	Reserved
23:12	freq_outb_sts	RO	0x0	Complementary Output Clock Frequency Monitor status. Value of the complementary output clock (OUTxB) frequency monitor status from the last monitoring window. Bit [11] = Complementary Output Clock 11 Frequency Monitor ... Bit [0] = Complementary Output Clock 0 Frequency Monitor 0x0 = Clock meets the monitoring criteria 0x1 = Clock does not meet the monitoring criteria, failure detected
11:0	freq_out_sts	RO	0x0	Output Clock Frequency Monitor status. Value of the true output clock (OUTx) frequency monitor status from the last monitoring window. Bit [11] = Output Clock 11 Frequency Monitor ... Bit [0] = Output Clock 0 Frequency Monitor 0x0 = Clock meets the monitoring criteria 0x1 = Clock does not meet the monitoring criteria, failure detected

3.19.14 OTP_STS

OTP Status.

OTP_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	manual_busy	RO	0x0	Manual access busy indicator. When high, indicates a manual request (including Program Assist) has started and is ongoing.
6	status	RO	0x0	OTP macro output pin status. Current value seen on the OTP macro output pin, synchronized to system clock.
5	vppmon	RO	0x0	OTP VPP_MON status. Current value of VPP_MON status, synchronized to system clock.
4	pwr_up	RO	0x0	OTP Power Up. Current value seen on the OTP PWR_UP pin, synchronized to system clock.

OTP_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3	reserved	RO	0x0	Reserved
2:0	fsm_state	RO	0x0	OTP control FSM state. Current value of the FSM state. 0x0 = RESET 0x1 = PWR_UP_RECOVERY 0x2 = RESET_RECOVERY 0x4 = IDLE 0x5 = SETUP 0x7 = PULSE 0x3 = HOLD 0x6 = RECOVERY

3.19.15 OTP_ERR_CNT

OTP CRC Error Count.

OTP_ERR_CNT Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	reserved	RO	0x0	Reserved
3:0	otp_crc_err_cnt	RW	0x0	OTP CRC Error Counter. This counter increments each time the loader detects a CRC error while reading the OTP, and saturates at 0xF. It is cleared by writing it to 0x0, and may be preset by writing the desired value. Preset may be used as a debug tool. Clear on read cannot be used due to read caching of the SSI AMBA master. This register can only be written if the block is not clock gated (otp_cg).

3.19.16 OTP_PARAM

OTP Parameters.

OTP_PARAM Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:14	otp_scr_size	RO	0x2	OTP Scratch Area Size in Words. Indicates the number of bytes reserved for the scratch area in the OTP: 0x0 = 0 bytes 0x1 = reserved 0x2 = 32 bytes 0x3 = reserved
13:12	otp_ea_size	RO	0x1	OTP Entry Address Size. Indicates the number of bytes used for the CSR address in the block entries. 0x0 = 1 bytes 0x1 = 2 bytes 0x2 = 4 bytes
11	otp_ba_size	RO	0x1	OTP Base Address Size. Indicates the number of bytes used for the base address pointer to each block within the OTP. 0x0 = 1 bytes 0x1 = 2 bytes

OTP_PARAM Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
10:8	otp_size	RO	0x2	OTP Size in Bytes. Indicates the effective number of bytes in the OTP. In differential mode, this indicates half of the physical number of bytes. 0x0 = 512B 0x1 = 1KB 0x2 = 2KB 0x3 = 4KB 0x4 = 8KB 0x5 = 16KB 0x6 = 32KB 0x7 = 64KB
7:3	otp_configs	RO	0x7	OTP User Configuration Count. Indicates the number of OTP user configurations supported, less one. 0x7 = 8 user configurations
2:0	otp_loader_ver	RO	0x4	OTP Loader Version. Indicates the OTP loader version. 0x0 = OTP loader used in Merlin test vehicle 0x1 = OTP loader used in Merlin rev A 0x2 = OTP loader used in VC7 test vehicle 0x3 = OTP loader used in VC7 rev A 0x4 = OTP loader used in Autoclock TV

3.19.17 DIG_POST_STS

Digital POST Status.

DIG_POST_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:24	reserved	RO	0x0	Reserved
23	csr_sig_post_fail_sts	RO	0x0	CSR signature monitor POST failure. Indicates an error was found in the CSR Signature Monitor POST.
22	dual_xtal_fail_post_fail_sts	RO	0x0	Dual crystal fail POST failure. Indicates an error was found during the Dual XTAL fail POST.
21	xtal_sw_post_fail_sts	RO	0x0	Crystal switching POST failure. Indicates an error was found during the XTAL switching POST.
20:9	freq_post_fail_sts	RO	0x0	Frequency monitor POST failure. Indicates an error was found during the output frequency monitor POST for the given output.
8	xtal1_st_err_post_fail_sts	RO	0x0	XTAL1 ST error POST failure. Indicates an error was found during the XTAL1 short term monitor POST.
7	xtal0_st_err_post_fail_sts	RO	0x0	XTAL0 ST error POST failure. Indicates an error was found during the XTAL0 short term monitor POST.
6	xtal_ppm_err_post_fail_sts	RO	0x0	XTAL PPM error POST failure. Indicates an error was found during the XTAL PPM error POST.
5	xtal_ppm_warn_post_fail_sts	RO	0x0	XTAL PPM warning POST failure. Indicates an error was found during the XTAL PPM warning POST.
4	los1_post_fail_sts	RO	0x0	Loss-of-Signal xtal 1 POST failure. Indicates an error was found during the XTAL1 Loss of signal POST.

DIG_POST_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
3	los0_post_fail_sts	RO	0x0	Loss-of-Signal xtal 0 POST failure. Indicates an error was found during the XTAL0 Loss of signal POST.
2	apll_lol_post_fail_sts	RO	0x0	APLL LOL POST failure. Indicates an error was found during the APLL LOL POST.
1	lbist_fail_sts	RO	0x0	Digital Logic BIST failure. Indicates an error was found in the digital logic BIST.
0	dig_post_fail_sts	RO	0x0	Digital POST failure. Indicates an error was found in the overall digital POST.

3.19.18 ANA_POST_STS

Analog POST Status.

ANA_POST_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:21	reserved	RO	0x0	Reserved
20	bias_cal_ana_post_fail_sts	RO	0x0	Analog POST Bias calibration failure. When 1, indicates Bias Calibration included in Analog POST Failed.
19	vco_cal_ana_post_fail_sts	RO	0x0	Analog POST VCO calibration failure. When 1, indicates VCO Calibration included in Analog POST Failed.
18	ana_post_ldo_low_fault_det_fail_sts	RO	0x0	Analog LDO Low Fault Detection POST Fail. When 1, indicates Analog LDO Low Fault Detection POST Failed.
17	ana_post_ldo_in_range_det_fail_sts	RO	0x0	Analog LDO In Range Detection POST Fail. When 1, indicates Analog LDO In Range Detection POST Failed.
16	ana_post_ldo_high_fault_det_fail_sts	RO	0x0	Analog LDO High Fault Detection POST Fail. When 1, indicates Analog LDO High Fault Detection POST Failed.
15	ana_post_ref_x1_ldo_fail_sts	RO	0x0	Analog POST Reference X1 LDO Fail. When 1, indicates Analog Reference X1 LDO POST Failed.
14	ana_post_ref_x0_ldo_fail_sts	RO	0x0	Analog POST Reference X0 LDO Fail. When 1, indicates Analog Reference X0 LDO POST Failed.
13	ana_post_apll_cp_ldo_fail_sts	RO	0x0	Analog POST APLL CP LDO Fail. When 1, indicates Analog APLL CP LDO POST Failed.
12	ana_post_apll_pfd_ldo_fail_sts	RO	0x0	Analog POST APLL PFD LDO Fail. When 1, indicates Analog APLL PFD LDO POST Failed.
11	ana_post_apll_vco_ldo_fail_sts	RO	0x0	Analog POST APLL VCO LDO Fail. When 1, indicates Analog APLL VCP LDO POST Failed.
10	ana_post_od_iod0_ldo_fail_sts	RO	0x0	Analog POST Output Divider IOD0 LDO Fail. When 1, indicates Analog Output Divider IOD0 LDO POST Failed.
9	ana_post_od_iod1_ldo_fail_sts	RO	0x0	Analog POST Output Divider IOD1 LDO Fail. When 1, indicates Analog Output Divider IOD1 LDO POST Failed.
8	ana_post_od_hpfod2_ldo_fail_sts	RO	0x0	Analog POST Output Divider HPFOD2 LDO Fail. When 1, indicates Analog Output Divider HPFOD2 LDO POST Failed.
7	ana_post_od_hpfod1_ldo_fail_sts	RO	0x0	Analog POST Output Divider HPFOD1 LDO Fail. When 1, indicates Analog Output Divider HPFOD1 LDO POST Failed.

ANA_POST_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
6	ana_post_od_hpfod0_ldo_fail_sts	RO	0x0	Analog POST Output Divider HPFOD0 LDO Fail. When 1, indicates Analog Output Divider HPFOD0 LDO POST Failed.
5	ana_post_od_lpfod1_ldo_fail_sts	RO	0x0	Analog POST Output Divider LPFOD1 LDO Fail. When 1, indicates Analog Output Divider LPFOD1 LDO POST Failed.
4	ana_post_od_lpfod0_ldo_fail_sts	RO	0x0	Analog POST Output Divider LPFOD0 LDO Fail. When 1, indicates Analog Output Divider LPFOD0 LDO POST Failed.
3	ana_post_dig_fod_ldo_fail_sts	RO	0x0	Analog POST Digital FOD LDO Fail. When 1, indicates Analog Digital FOD LDO POST Failed.
2	ana_post_dig_apll_ldo_fail_sts	RO	0x0	Analog POST Digital APLL Divider LDO Fail. When 1, indicates Analog Digital APLL Divider LDO POST Failed.
1	ana_post_dig_block_ldo_fail_sts	RO	0x0	Analog POST Digital Block LDO Fail. When 1, indicates Analog Digital Block LDO POST Failed.
0	ana_post_fail_sts	RO	0x0	Analog POST Fail. When 1, indicates analog POST failed.

3.19.19 DIG_POST_FSM_STS

Digital POST State Machine Status.

DIG_POST_FSM_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:0	dig_post_fsm_sts	RO	0x0	Digital POST state machine status. Indicates the current state of the Digital POST state machine.

3.19.20 ANA_POST_FSM_STS

Digital POST State Machine Status.

ANA_POST_FSM_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:9	reserved	RO	0x0	Reserved
8:4	ana_post_count_sts	RO	0x0	Analog POST state machine status. Indicates the current count of the analog POST state machine.
3:0	ana_post_fsm_sts	RO	0x0	Analog POST state machine status. Indicates the current state of the analog POST state machine.

3.20 DCD_STATUS

DCD Status registers.

Table 22. DCD_STATUS Register Index

Offset (Hex)	Register Module Base Address: 0x2C0	
	Register Name	Register Description
0x0	DCD_CALIB_STS	DCD Calibration Status
0x4	DCD_CALIB2_STS	DCD Accelerated Calibration Status

3.20.1 DCD_CALIB_STS

DCD Calibration Status.

DCD_CALIB_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:15	gro_st_cnt	RO	0x0	DCD Calibration GRO State Counter. The status read through this field is selected by dcd_status_sel: 0x0: Invalid GRO state counter. 0x1: GRO phase status bits 20:15 in gro_st_cnt[5:0]. gro_st_cnt[16:6] are zero. 0x2: Captured GRO status 0x3: GRO status from analog All status information in this register is latched when the register is read. The read back value is the previously latched value. Therefore, the first time the register is read, the read data must be ignored, and subsequent reads return the data latched when the prior read occurred. Also, this register must be read using a 4-byte burst read to get a consistent value across all 4 bytes.
14:0	i_err_sts	RO	0x0	DCD Calibration i_error Status. The status read through this field is selected by dcd_status_sel: 0x0: DCD calibration low pass filter value. This is a signed 2's complement number. 0x1: GRO phase status bits 14:0 0x2: DAC control value in i_err_sts[7:0]. i_err_sts[14:8] are zero. 0x3: Slow calibration value All status information in this register is latched when the register is read. The read back value is the previously latched value. Therefore, the first time the register is read, the read data must be ignored, and subsequent reads return the data latched when the prior read occurred. Also, this register must be read using a 4-byte burst read to get a consistent value across all 4 bytes.

3.20.2 DCD_CALIB2_STS

DCD Accelerated Calibration Status.

DCD_CALIB2_STS Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:1	reserved	RO	0x0	Reserved
0	dcd_accel_active	RO	0x0	DCD Accelerated Calibration Status. Indicates whether accelerated calibration (duration set by dcd_accel_fast_lock and dcd_accel_settle) is in progress. 0x0 = accelerated calibration completed or FOD is in reset 0x1 = accelerated calibration is active

3.21 CTRL

Control registers.

Table 23. CTRL Register Index

Offset (Hex)	Register Module Base Address: 0x2E0	
	Register Name	Register Description
0x0	CSR_SIG	Expected CSR Signature
0x4	REG_LOCK	Register Lock Key
0x5	INIT_SYNC	Init/Synchronization Register
0x6	MISC_CTRL	VCO/Bias/CSR Signature Control

Table 23. CTRL Register Index

Offset (Hex)	Register Module Base Address: 0x2E0	
	Register Name	Register Description
0x7	GPO_CTRL	GPO Output Control
0x8	OUT_CTRL	Output Control

3.21.1 CSR_SIG

Expected CSR Signature.

CSR_SIG Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
31:0	csr_sig_exp	RW	0x0	Expected CSR Signature. Sets the expected value of the CRC-32 calculated over all CSRs up to the STATUS CSRs. If the CRC-32 value calculated during a CSR check (readable in csr_sig_calc) does not match csr_sig_exp, then either the csr_sig_reload or csr_sig_fail event bit is set to 1 according to csr_sig_err_mode.

3.21.2 REG_LOCK

Register Lock Key.

REG_LOCK Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:0	reg_lock_key	WO	0x0	Configuration register lock key. Writing this field with 0xCB sets the config_reg_ro bit to 1. Writing this field with 0x34 clears the config_reg_ro bit to 0. This will be implemented for Rev A.

3.21.3 INIT_SYNC

Init/Synchronization Register.

INIT_SYNC Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:3	reserved	RO	0x0	Reserved
2	out_rst	RW	0x0	Output Driver Reset. This bit resets and disables all output drivers. Reset assertion acts asynchronously and may causes output glitches or runt pulses. Reset assertion acts synchronously. Inverted and connected to sync_done.
1	divider_sync	RW1S	0x0	Divider Synchronization. Writing this bit to 1 synchronizes the Output Dividers. The output clocks will be squelched for approximately 10us. Self-cleared when the synchronization completes.
0	apll_reinit	RW1S	0x0	APLL Reinitialization. Writing this bit to 1 re-starts the startup sequence from the VCO calibration step, including divider synchronization. Self-cleared when the reinitialization completes.

3.21.4 MISC_CTRL

VCO/Bias/CSR Signature Control.

MISC_CTRL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7:4	reserved	RO	0x0	Reserved
3	vco_recal	RW	0x0	VCO Calibration trigger. Triggers VCO re-calibration when written to 1. This bit must be written to 0 before it may be triggered again by writing it to 1. This is for debugging only. For full APLL locking, appl_reinit is required.
2	bias_recal	RW	0x0	Bias Calibration trigger. Triggers bias re-calibration when written to 1. This bit must be written to 0 before it may be triggered again by writing it to 1.
1	reserved	RO	0x0	Reserved
0	csr_sig_trig	WO	0x0	CSR Signature Check Trigger. Manually triggers a CSR signature check when written to 1, if an automatic check is not already in progress. Self clears.

3.21.5 GPO_CTRL

GPO Output Control.

GPO_CTRL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
7	reserved	RO	0x0	Reserved
6	gpo6_ctrl	RW	0x0	GPO output control signal value for GPIO6. Sets the value to drive on GPIO6 pin when configured as a general purpose output by gpio_func.
5	gpo5_ctrl	RW	0x0	GPO output control signal value for GPIO5. Sets the value to drive on GPIO5 pin when configured as a general purpose output by gpio_func.
4	gpo4_ctrl	RW	0x0	GPO output control signal value for GPIO4. Sets the value to drive on GPIO4 pin when configured as a general purpose output by gpio_func.
3	gpo3_ctrl	RW	0x0	GPO output control signal value for GPIO3. Sets the value to drive on GPIO3 pin when configured as a general purpose output by gpio_func.
2	gpo2_ctrl	RW	0x0	GPO output control signal value for GPIO2. Sets the value to drive on GPIO2 pin when configured as a general purpose output by gpio_func.
1	gpo1_ctrl	RW	0x0	GPO output control signal value for GPIO1. Sets the value to drive on GPIO1 pin when configured as a general purpose output by gpio_func.
0	gpo0_ctrl	RW	0x0	GPO output control signal value for GPIO0. Sets the value to drive on GPIO0 pin when configured as a general purpose output by gpio_func.

3.21.6 OUT_CTRL

Output Control.

OUT_CTRL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
15:13	reserved	RO	0x0	Reserved
12	goe	RW	0x1	Output Global OE. This bit allows manual CSR control of the global output OE.
11	out11_dis	RW	0x0	OUT11 and/or OUT11b Driver disable. Forces both OUT11 and OUT11b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information. When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means. 0x0 = enabled 0x1 = disabled
10	out10_dis	RW	0x0	OUT10 and/or OUT10b Driver disable. Forces both OUT10 and OUT10b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information. When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means. 0x0 = enabled 0x1 = disabled
9	out9_dis	RW	0x0	OUT9 and/or OUT9b Driver disable. Forces both Out9 and Out9b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information. When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means. 0x0 = enabled 0x1 = disabled
8	out8_dis	RW	0x0	OUT8 and/or OUT8b Driver disable. Forces both OUT8 and OUT8b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information. When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means. 0x0 = enabled 0x1 = disabled
7	out7_dis	RW	0x0	OUT7 and/or OUT7b Driver disable. Forces both OUT7 and OUT7b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information. When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means. 0x0 = enabled 0x1 = disabled

OUT_CTRL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
6	out6_dis	RW	0x0	<p>OUT6 and/or OUT6b Driver disable. Forces both OUT6 and OUT6b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>
5	out5_dis	RW	0x0	<p>OUT5 and/or OUT5b Driver disable. Forces both OUT5 and OUT5b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>
4	out4_dis	RW	0x0	<p>OUT4 and/or OUT4b Driver disable. Forces both OUT4 and OUT4b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>
3	out3_dis	RW	0x0	<p>OUT3 and/or OUT3b Driver disable. Forces both OUT3 and OUT3b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>
2	out2_dis	RW	0x0	<p>OUT2 and/or OUT2b Driver disable. Forces both OUT2 and OUT2b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>

OUT_CTRL Bit Field Descriptions				
Bit Field	Field Name	Field Type	Default Value	Description
1	out1_dis	RW	0x0	<p>OUT1 and/or OUT1b Driver disable. Forces both OUT1 and OUT1b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>
0	out0_dis	RW	0x0	<p>OUT0 and/or OUT0b Driver disable. Forces both OUT0 and OUT0b Drivers to be disabled if in differential mode or force OUT Driver to be disabled if in CMOS mode. Refer to Output Enable Control for more information.</p> <p>When option 0x0 is selected the OUTx and/or OUTxb Driver is enabled if it is not disabled by other means.</p> <p>0x0 = enabled 0x1 = disabled</p>

4. Revision History

Revision	Date	Description
1.00	Apr 25, 2024	Initial release.

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